HAC TEST REPORT FOR T-coil

Test Item: Summary Result T-coil Category = T3

REPORT NO.: TL980116L05

MODEL NO.: RHOD500

RECEIVED: Feb. 05, 2009

TESTED : Apr. 09, 2009

ISSUED: Apr. 20, 2009

APPLICANT: HTC Corporation

ADDRESS: No. 23, Xinghua Rd., Taoyuan City, 330, Taiwan, R.O.C.

ISSUED BY: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch

LAB ADDRESS: No. 47, 14th Ling, Chia Pau Tsuen, Lin Kou Hsiang, Taipei Hsien 244, Taiwan, R.O.C.

TEST LOCATION: No. 19, Hwa Ya 2nd Rd, Wen Hwa Tsuen, Kwei Shan Hsiang, Taoyuan Hsien 333, Taiwan, R.O.C.

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1. CERTIFICATION

PRODUCT : Pocket PC Phone
MODEL NO. : RHOD500
APPLICANT : HTC Corporation
TESTED : Apr. 09, 2009
TEST SAMPLE : ENGINEERING SAMPLE
STANDARDS : **FCC 47CFR Part 20.19**
ANSI C63.19 2007
TEST ITEM: T-coil performance

The above equipment (Model: RHOD500) has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch,** and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

PREPARED BY : _____ , **DATE:** Apr. 20, 2009
Andrea Hsia / Specialist

TECHNICAL ACCEPTANCE : _____ , **DATE:** Apr. 20, 2009
Responsible for RF Long Chen / Senior Engineer

APPROVED BY : _____ , **DATE:** Apr. 20, 2009
Gary Chang / Assistant Manager

2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF THE EUT

PRODUCT	Pocket PC Phone
MODEL NO.	RHOD500
FCC ID	NM8RHOD500
POWER SUPPLY	3.7Vdc from rechargeable lithium battery 5.0Vdc from power adapter 5.0Vdc from host equipment
CLASSIFICATION	Portable device, production unit
MODULATION TYPE	OQPSK, HPSK
FREQUENCY RANGE	824MHz ~ 849MHz (CDMA850) 1850MHz ~ 1910MHz (CDMA1900)
CHANNEL FREQUENCIES UNDER TEST AND ITS CONDUCTED OUTPUT POWER	Refer to Section 2.4
T-COIL CATEGORY	T3
ANTENNA TYPE	PIFA antenna with 0dBi gain for CDMA850 PIFA antenna with 1dBi gain for CDMA1900
DATA CABLE	1.25m non-shielded USB cable without core (Brand: MEC & ACON)
I/O PORTS	Refer to user's manual
ACCESSORY DEVICES	Adapter, Battery

NOTE:

1. The communicated functions of EUT listed as below:

		850MHz	1900MHz	
3G	CDMA	√	√	**With WLAN 802.11b/g + BT 2.0 with EDR + GPS (CDMA rev. A)**
	1*EVDO	√	√	

2. The following accessory is for support units only.

PRODUCT	MODEL	DESCRIPTION
Earphone	HS G335	3.5mm connector 1.3m non-shielded without core

3. The EUT uses following LCM panels.

PRODUCT	BRAND	MODEL
LCM (Main)	Auo	H361VL01
LCM (2nd source)	EID	L4F00390T00
LCM (3rd source)	Sharp	LS036Y1LX01

**LCM (Main) was found to be the worst case and was selected for the final test configuration.

4. The EUT uses following Cameras.

PRODUCT	BRAND	MODEL
Camera (Main)	FOXCONN	3M-AF
Camera (2nd source)	LITEON	08PM17

** Camera (Main) was found to be the worst case and was selected for the final test configuration.

5. For USB cable, after pre-tested found brand: ACON was the worst therefore chosen for the final test and presented in the test report.
6. The EUT uses following batteries.

BATTERY 1: (MANUFACTORY: WELLDONE)	
BRAND	hTC
MODEL	RHOD160
RATING	3.7Vdc, 1500mAh, 5.55Whr

BATTERY 2: (MANUFACTORY: FORMOSA)	
BRAND	hTC
MODEL	RHOD160
RATING	3.7Vdc, 1500mAh, 5.55Whr

BATTERY 3: (MANUFACTORY: SIMPLO)	
BRAND	hTC
MODEL	RHOD160
RATING	3.7Vdc, 1500mAh, 5.55Whr

**After pre-tested, battery 2 was the worst case for the final test and presented in the test report.

7. The EUT were operated with following power adapters:

ADAPTER 1 (MANUFACTORY: Delta)	
BRAND	hTC
MODEL	TC P300
INPUT	100-240Vac, 0.2A, 50-60Hz
OUTPUT	5Vdc, 1A
POWER LINE	1.25m non-shielded cable without core

ADAPTER 2 (MANUFACTORY: Foxlink) (second source)	
BRAND	hTC
MODEL	TC P300
INPUT	100-240Vac, 0.2A, 50-60Hz
OUTPUT	5Vdc, 1A
POWER LINE	1.25m non-shielded cable without core

8. Refer to following table for MEID no.:

MEID NO.
A1000007******

9. Hardware version: NA
10. Software version: NA
11. The above EUT information was declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.

2.2 DESCRIPTIONOF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

NO.	PRODUCT	BRAND	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
1	Universal Radio Communication Tester	R&S	CMU200	101372	Jan. 8, 2010

NO.	SIGNAL CABLE DESCRIPTION OF THE ABOVE SUPPORT UNITS
1	NA

NOTE: All power cords of the above support units are non shielded (1.8m).

2.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

According to the specifications of the manufacturer, this product must comply with the requirements of the following standards:

FCC 47CFR Part 20.19

ANSI C63.19 - 2007

All test items have been performed and recorded as per the above standards.

2.4 MEASUREMENTS FOR CERTIFICATION OF 3G DEVICES

For CDMA devices, RC1 and RC3 CDMA modes are considered in S055 service option. In addition, RC1 and RC3 modes are considered in S02 service option. The conducted power measurements for each mode are shown in the table below.

CDMA 2000 CONDUCTED POWER													
CHAN.	FREQ. (MHz)	CDMA 2000	RAW VALUE (dBm)					CORR. FACTOR (dB)	OUTPUT POWER (dBm)				
		RC	SO2	SO55	TDSO SO32 (FCH)	TDSO SO32 (FCH +SCH)	SO3		SO2	SO55	TDSO SO32 (FCH)	TDSO SO32 (FCH+ SCH)	SO3
1013	824.7	RC1	19.12	19.33	-	-	19.32	4.40	23.52	23.73	-	-	23.72
		RC3	19.19	19.45	18.96	18.88	19.42	4.40	23.59	23.85	23.36	23.28	23.82
384	836.5	RC1	18.89	19.18	-	-	19.15	4.40	23.29	23.58	-	-	23.55
		RC3	18.95	19.22	18.78	18.73	19.21	4.40	23.35	23.62	23.18	23.13	23.61
777	848.3	RC1	19.20	19.50	-	-	19.43	4.40	23.60	23.90	-	-	23.83
		RC3	19.25	19.62	19.28	19.20	19.52	4.40	23.65	24.02	23.68	23.60	23.92

CDMA 2000 CONDUCTED POWER													
CHAN.	FREQ. (MHz)	CDMA 2000	RAW VALUE (dBm)					CORR. FACTOR (dB)	OUTPUT POWER (dBm)				
		RC	SO2	SO55	TDSO SO32 (FCH)	TDSO SO32 (FCH +SCH)	SO3		SO2	SO55	TDSO SO32 (FCH)	TDSO SO32 (FCH+ SCH)	SO3
25	1851.25	RC1	17.77	18.21	-	-	18.05	5.60	23.37	23.81	-	-	23.65
		RC3	17.98	18.31	18.01	17.85	18.14	5.60	23.58	23.91	23.61	23.45	23.74
600	1880.00	RC1	17.33	17.66	-	-	17.55	5.60	22.93	23.26	-	-	23.15
		RC3	17.66	17.90	17.29	17.12	17.81	5.60	23.26	23.50	22.89	22.72	23.41
1175	1908.75	RC1	17.83	18.24	-	-	18.20	5.60	23.43	23.84	-	-	23.80
		RC3	18.06	18.43	18.11	17.91	18.24	5.60	23.66	24.03	23.71	23.51	23.84

For CDMA devices, **RC1 S03 mode is used for T-coil compliance evaluation.** This RC1 S03 is used for measurements in section x of this report. As per the recent presentation by Qualcomm to the FCC on March 15, 2007, RC1 S03 combination represents the appropriate configuration for T-coil testing.

3. SUMMARY OF THE TEST RESULTS

ANSI C63.19 (2007) T-coil result				
Mode	**Test**	**Test Results**	**T-Rating**	**Verdit**
CDMA850	Min. Field Strength (AMB1), dB A/m	-10.3	3	PASS
	Min. Signal Quality (ABM1/ABM2), dB	23.4	3	PASS
	Frequency Response @ Axial position			PASS
CDMA1900	Min. Field Strength (AMB1), dB A/m	-15.2	3	PASS
	Min. Signal Quality (ABM1/ABM2), dB	24.0	3	PASS
	Frequency Response @ Axial position			PASS
Overall T-Rating :		T3		
M-Rating* :		M4		
HAC Category Rating :		M4,T3		

* M-rating obtained from HAC RF report.

4. GENERAL INFORMATION OF THE DASY 5 SYSTEM

4.1 GENERAL INFORMATION OF TEST EQUIPMENT

DASY5 (Software 5.0 Build 125) consists of high precision robot, probe alignment sensor, phantom, robot controller, controlled measurement server and near-field probe. The robot includes six axes that can move to the precision position of the DASY 5 software defined.
The DASY 5 software can define the area that is detected by the probe. The robot is connected to controlled box. Controlled measurement server is connected to the controlled robot box.
The DAE includes amplifier, signal multiplexing, AD converter, offset measurement and surface detection. It is connected to the Electro-optical coupler (ECO). The ECO performs the conversion form the optical into digital electric signal of the DAE and transfers data to the PC.
This system consists of the following items:

AM1DV3 Audio Magnetic Field Probe

The AM1D probe is an active probe with a single sensor. It is fully RF-shielded and has a rounded tip 6mm in diameter incorporating a pickup coil with its center offset 3mm from the tip and the sides. The symmetric signal preamplifier in the probe is fed via the shielded symmetric output cable from the AMMI with a 48V “phantom” voltage supply. The 7-pin connector on the back in the axis of the probe does not carry any signals. It is mounted to the DAE for the correct orientation of the sensor. If the probe axis is tilted 54.7 degree from the vertical, the sensor is approximately vertical when the signal connector is at the underside of the probe (cable hanging downwards).

Specification:

Frequency range	0.1 ~ 20 kHz (RF sensitivity <-100dB, fully RF shielded)
Sensitivity	<-50dB A/m @ 1 kHz
Pre-amplifier	40 dB, symmetric
Dimensions	Tip diameter/ length: 6/ 290 mm, sensor according to ANSI-C63.19

DATA ACQUISITION ELECTRONICS (DAE)

CONSTRUCTION

The data acquisition electronics (DAE 4) consists of a highly sensitive electrometer grade preamplifier with auto-zeroing, a channel and gain-switching multiplex, a fast 16 bit AD converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock. The mechanical probe is mounting device includes two different sensor systems for frontal and sideways probe contacts. They are used for mechanical surface detection and probe collision detection. The input impedance of the DAE3,4 box is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.

AMMI

The Audio Magnetic Measuring Instrument (AMMI) is a desktop 19-inch unit containing a sampling unit, a waveform generator for test and calibration signals, and a USB interface.

Specification:

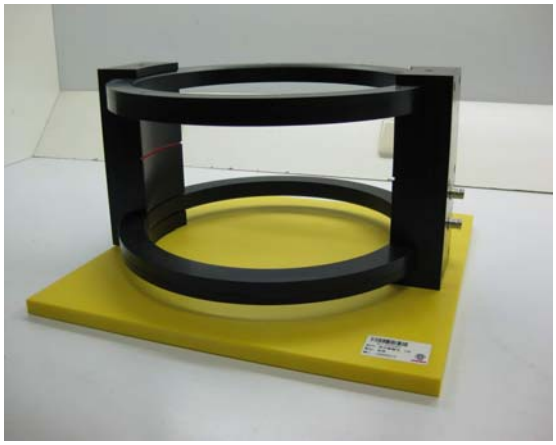
Sampling rate	48 kHz/24 bit
Dynamic range	85 dB
Test signal generation	User selectable and predefined (via PC)
Calibration	Auto-calibration/full system calibration using AMCC with monitor output
Connection:	Front connectors Audio Out - audio signal to the base station simulator Coil Out - test and calibration signal to the AMCC Coil In - monitor signal from the AMCC BNO connector Probe In - probe signal
Dimensions	482 x 65 x 270 mm

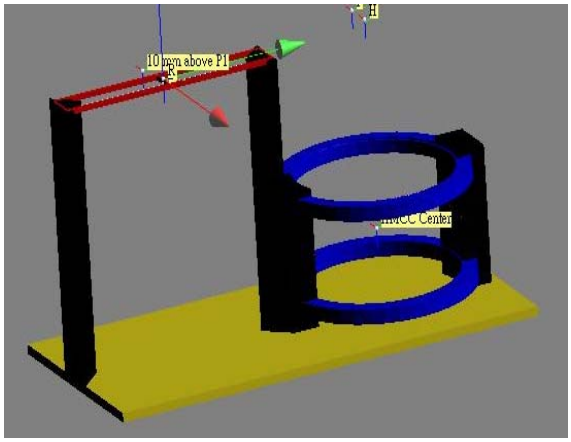
AMCC

The Audio Magnetic Calibration coil is a Helmholtz Coil designed according to ANSI C63.19-2007 section D.9, for calibration of the AM1D probe. The two horizontal coils generate a homogeneous magnetic field in the z direction. The DC input resistance is adjusted to approximately 50 Ohm by a series resistor, and a shunt resistor of 10 Ohm allows monitoring the current with a scale of 1:10.

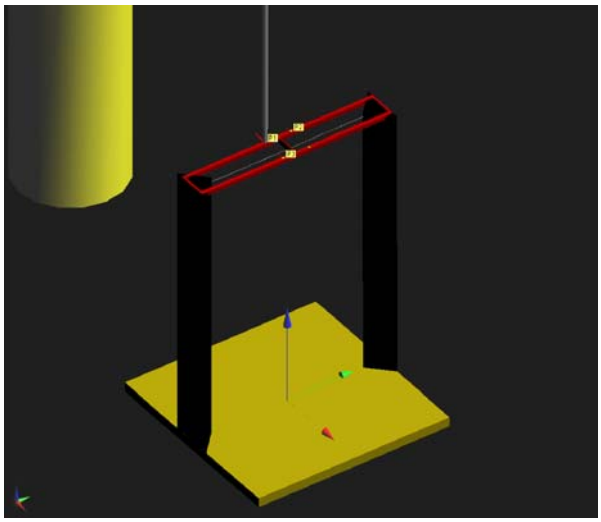
Specification:

Coil In	typically 50 Ohm
Coil Monitor	10Ohm ±1%(100mV corresponding to 1 A/m)
Dimensions	370 x 370 x 196 mm





HAC ARCH



DIMENSIONS 370 x 370 x 370mm

DEVICE HOLDER

CONSTRUCTION Supports accurate and reliable positioning of any phone effect on near field <+/- 0.5dB

4.2 TEST SYSTEM CONFIGURATION

Figure 4.2: T-Coil setup with HAC Test Arch and AMCC

4.3 TEST EQUIPMENT LIST

ITEM	NAME	BAND	TYPE	SERIES NO.	DATE OF CALIBRATION	DUE DATE OF CALIBRATION
1	AUDIO BAND MAGNETIC PROBE	SPEAG	AM1DV3	3060	Dec. 03,2008	Dec. 02,2009
2	DAE	SPEAG	DAE4	861	Sep. 22, 2008	Sep. 21, 2009
3	AUDIO BAND MAGNETIC MEASURING INSTRUMENT	SPEAG	AMMI	1075	NA	NA
4	HELMHOLTZ COIL	SPEAG	AMCC	1076	NA	NA
5	HAC ARCH	SPEAG	HAC ARCH	1034	NA	NA
6	ROBOT POSITIONER	STAUBLI UNIMATION	NA	NA	NA	NA

NOTE1: All test equipment has been calibrated by the SPEAG. Please reference" APPENDIX B "for the calibration report.

NOTE2: Before starting the measurement, all test equipment shall be warmed up for 30min.

4.4 T-COIL MEASUREMENT UNCERTAINTY

HAC UNCERTAINTY BUDGET ACCORDING TO ANSI C63.19							
ERROR DESCRIPTION	UNCERTAINTY VALUE	PROBABILITY DISTRIBUTION	DIV.	(Ci) ABM1	(Ci) ABM2	STD. UNC. AMB1	STD. UNC. AMB2
PROBE SENSITIVITY							
Reference level	±3.0%	Normal	1	1	1	±3.0%	±3.0%
AMCC geometry	±0.4%	Rectangular	√3	1	1	±0.2%	±0.2%
AMCC current	±1.0%	Rectangular	√3	1	1	±0.6%	±0.6%
Probe positioning during calibration	±0.1%	Rectangular	√3	1	1	±0.1%	±0.1%
Noise contribution	±0.7%	Rectangular	√3	0.0143	1	±0.0%	±0.4%
Frequency slope	±5.9%	Rectangular	√3	0.1	1	±0.3%	±3.5%
PROBE SYSTEM							
Repeatability / Drift	±1.0%	Rectangular	√3	1	1	±0.6%	±0.6%
Linearity / Dynamic range	±0.6%	Rectangular	√3	1	1	±0.4%	±0.4%
Acoustic noise	±1.0%	Rectangular	√3	0.1	1	±0.1%	±0.6%
Probe angle	±2.3%	Rectangular	√3	1	1	±1.4%	±1.4%
Spectral processing	±0.9%	Rectangular	√3	1	1	±0.5%	±0.5%
Integration time	±0.6%	Normal	1	1	5	±0.6%	±3.0%
Field distribution	±0.2%	Rectangular	√3	1	1	±0.1%	±0.1%
TEST SIGNAL							
Reference signal spectral response	±0.6%	Rectangular	√3	0	1	±0.0%	±0.4%
POSITIONING							
Probe positioning	±1.9%	Rectangular	√3	1	1	±1.1%	±1.1%
Phantom thickness	±0.9%	Rectangular	√3	1	1	±0.5%	±0.5%
DUT positioning	±1.9%	Rectangular	√3	1	1	±1.1%	±1.1%
EXTERNAL CONTRIBUTIONS							
RF interference	±0.0%	Rectangular	√3	1	0.3	±0.0%	±0.0%
Test signal variation	±2.0%	Rectangular	√3	1	1	±1.2%	±1.2%
Combined Standard Uncertainty (ABM):						**±4.1%**	**±6.1%**
Extended Standard Uncertainty (k=2) [%]:						**±8.1%**	**±12.3%**

The uncertainty budget for HAC Audio Band Magnetic Field (AMB) assessment according to ANSI C63.19-2007.The budget is valid for the DASY system and represents a worst- case analysis. For specific tests and configurations, the uncertainty could be smaller.

5. SYSTEM VALIDATION & CALIBRATION

At the beginning of the HAC T-coil measurement, a 3-phase calibration was performed per Speag instruction to ensure accurate measurement of the voltages and ABM field. Reference input level was also validated and calibrated per C63.19.

5.1 CABLING OF SYSTEM

The principal cabling of the T-Coil setup is shown in Figure 6.1 All cables provided with the basic setup have a length of approximately 5 m.

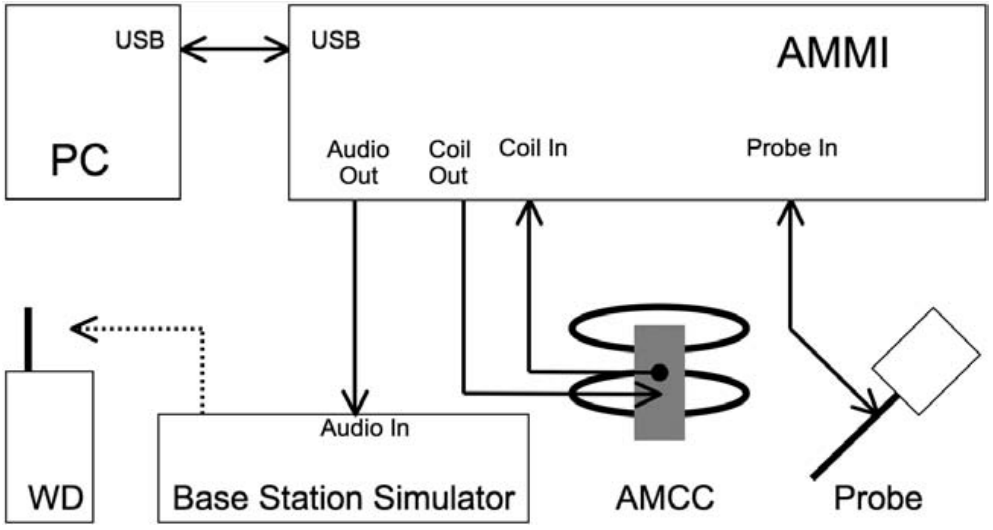


Figure 5.1: -Coil setup cabling

5.2 INPUT CHANNEL CALIBRATION

Phase 1: The AMMI audio output was switched off, and a 200 mV_pp symmetric rectangular signal of 1 kHz was generated and internally connected directly to both channels of the sampling unit (coil in, probe in).

Phase 2: The AMMI audio output was off, and a 20 mV_pp symmetric 100 Hz signal was internally connected.

The signals during phases 1 and 2 were available at the output on the rear panel of the AMMI. The output must however not be loaded in order not to influence the calibration. After the first two phases, the two input channels were both calibrated for absolute measurements of voltages. The resulting factors were displayed above the multimeter window.

After phases 1 and 2, the input channels were calibrated to measure exact voltages.

5.3 PROBE CALIBRATION IN AMCC

Phase 3: Probe Calibration in AMCC

The probe sensitivity at **1 kHz is 0.00731303V / (A/m)** was calibrated by AMCC coil for verification of setup performance. The evaluated probe sensitivity was able to be compared to the calibration of the AM1D probe. The frequency response and sensitivity was shown in appendix A1. The probe signal is represented after application of an ideal integrator. The green curve represents the current though the AMCC, the blue curve the integrated probe signal. The difference between the two curves is equivalent to the frequency response of the probe system and shows the characteristics. The probe/system complies with the frequency response and linearity requirements in C63.19 according to the Speag's calibrated report as shown in appendix C1

(1)The frequency response has been tested within +/- 0.5 dB of ideal differentiator from 100 Hz to 10 kHz.

(2)The linearity has also been tested within 0.1dB from 5 dB below limitation to 16 dB above noise level. The AMCC coil is qualified according to certificate report that shown in appendix C2.

5.4 REFERENCE INPUT LEVEL

An Input Level is measured to verify that it is within +/-0.2 dB from the Reference Input Level in section 6.3.2.1 of ANSI C63.19-2007.

According to ANSI C63.19:2007 section 6.3.2.1, the normal speech input level for HAC T-coil tests shall be set to -16dBm0 for GSM and UMTS (WCDMA), and to -18 dBm0 for CDMA. This technical note shows a possibility to evaluate and set the correct level with the HAC T-Coil setup with a Rohde & Schwarz communication tester CMU200 with audio option B52 and B85.

5.4.1 TARGET LEVEL FOR "AUDIO OUT" OF THE AMMI

(**CMU200 Audio Codec Calibration)**

Measured data is shown in Table 5.4.1. This target level takes into account the difference between AMMI's and CMU's reference levels.

Table 5.4.1: Measured Input Level

Modulation	Reference Input Level from ANSI C63.19 (dBm0)	CMU's 0dBm0 Input Reference Value (dB)	Target Level for "Audio Out" of AMMI (dBm0)
CDMA	-18	-2.50	-20.5

5.4.2 THE SIGNAL LEVEL FOR "AUDIO OUT" OF THE AMMI

(AMMI Signal Verification)

Signal Verification has been conducted on the same days as DUT measurements. If it is not within +/-0.2 dB, the gain settings in the DASY template are adjusted. The obtained results are displayed in Table 5.4.2.

Table 5.4.2: Measured Input Level

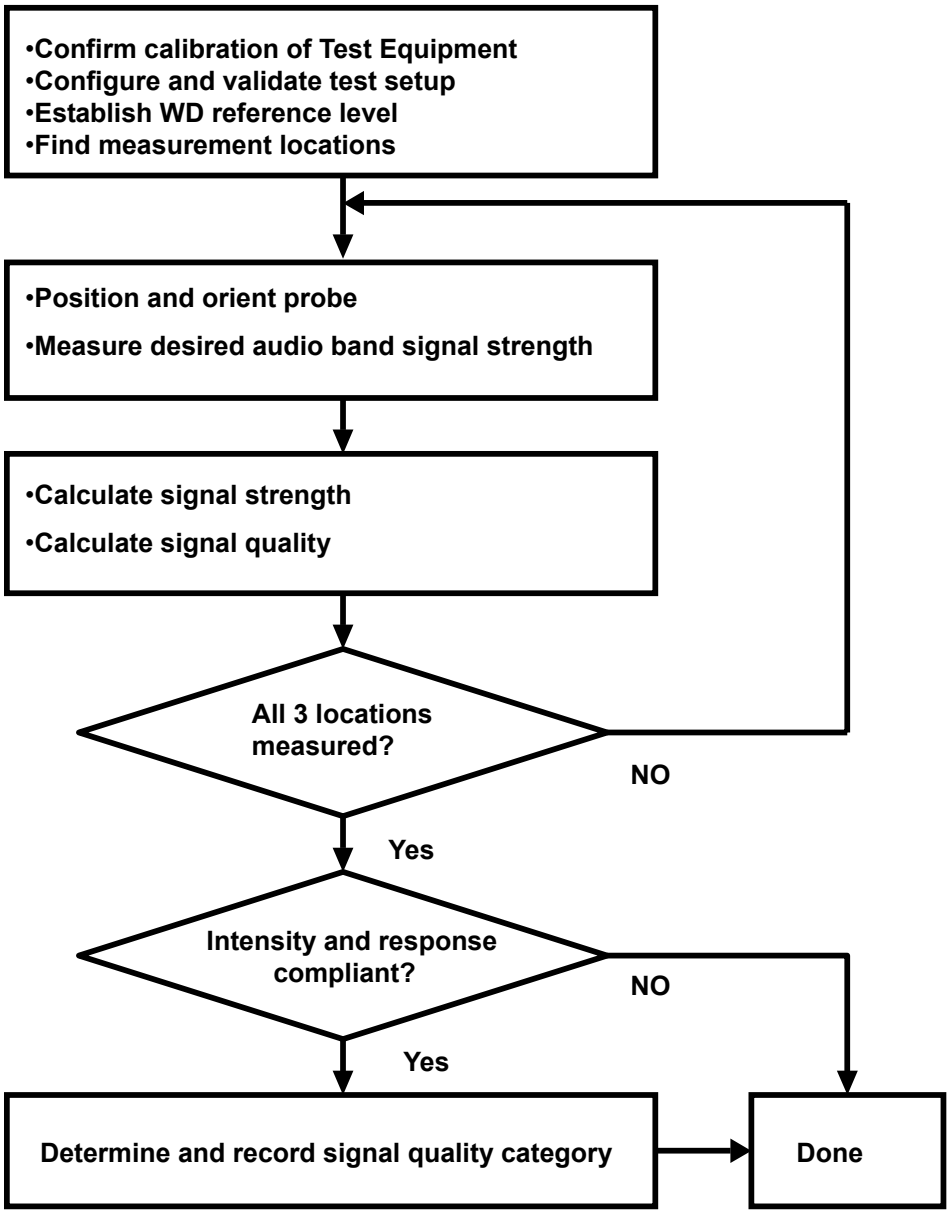
Modulation	Signal	Measured Level for "Audio Out" of AMMI (dBm0)	Target Level for "Audio Out" of AMMI (dBm0)	Delta (dB)
CDMA	Narrowband	-20.17	-20.5	0.44
	Broadband	-20.27		0.34

5.5 REFERENCE INPUT OF AUDIO SIGNAL SPECTRUM

With the reference job "use as reference" in the beginning of a procedure, measure the spectrum of the current when applied to the AMCC, i.e. the input magnetic field spectrum, as shown in the **appendix A2**. For this, the delay of the window shall be set to a multiple of the signal period and at least 2s. From the measurement on the device, using the same signal, the postprocessor deducts the input spectrum, so the result represents the net DUT response.

6. T-COIL TEST PROCEDURE

The device was positioned and setup according to ANSI C63.19-2007. The following shows the T-Coil Signal measurement flowchart:



The following steps were a typical test scan for the wireless communications device:

1. Geometry and signal check: system probe alignment, proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
   A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the test Arch.
2. Set the reference drive level of signal voice defined in C63.19 per 6.3.2.1, as shown in the **appendix A2** of this report
3. The ambient and test system background noise (dB A/m) was measured as well as ABM2 over the full measurement. The maximum noise level must be at least 10dB below the limit of C63.19 per 7.3.2.
   For the three probe positions, noise spectrum plots for the highest ambient noise are given in **appendix A3.**
4. The DUT was positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
5. The DUT operation for maximum rated RF output power was configured and connected by using of coaxial cable connection to the base station simulator at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The DUT audio output was positioned tangent (as physically possible) to the measurement plane.
6. The DUT's RF emission field was eliminated from T-coil results by using a well RF-shielding of the probe, AM1D, and by using of coaxial cable connection to a Base Station Simulator. One test channel was pre-measurement to avoid this possibility.
7. Determined the optimal measurement locations for the DUT by following the three steps, coarse resolution scan, fine resolution scans, and point measurement, as described in C63.19 per 6.3.4.4. At each measurement locations, samples in the measurement window duration were evaluated to get ABM1 and the signal spectrum. The noise measurement was performed after the scan with the signal, the same happened, just with the voice signal switched off. The ABM2 was calculated from this second scan.

   (1) Coarse resolution scans (1 KHz signal at 50 x 50 mm grid area with 10 mm spacing). Only ABM1 was measured in order to find the location of T-Coil source.
   (2) Fine resolution scans (1 KHz signal at 10 x 10 mm grid area with 2 mm spacing). The positioned appropriately based on optimal AMB1 of coarse resolution scan. Both ABM1 and ABM2 were measured in order to find the location of the SNR point.
   (3) Point measurement (1 KHz signal) for ABM1 and ABM2 in axial, radial transverse and radial longitudinal. The positioned appropriately based on optimal SNR of fine resolution scan. The SNR was calculated for axial, radial transverse and radial longitudinal orientation.

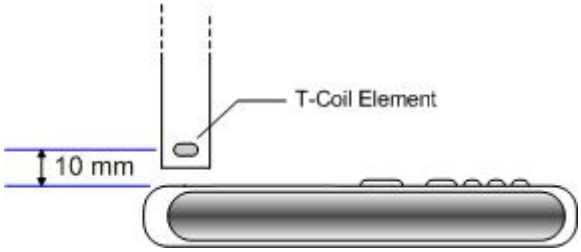
(4) Point measurement (300Hz to 3 KHz signal) for frequency response in axial. The positioned appropriately based on optimal SNR of fine resolution axial scan.

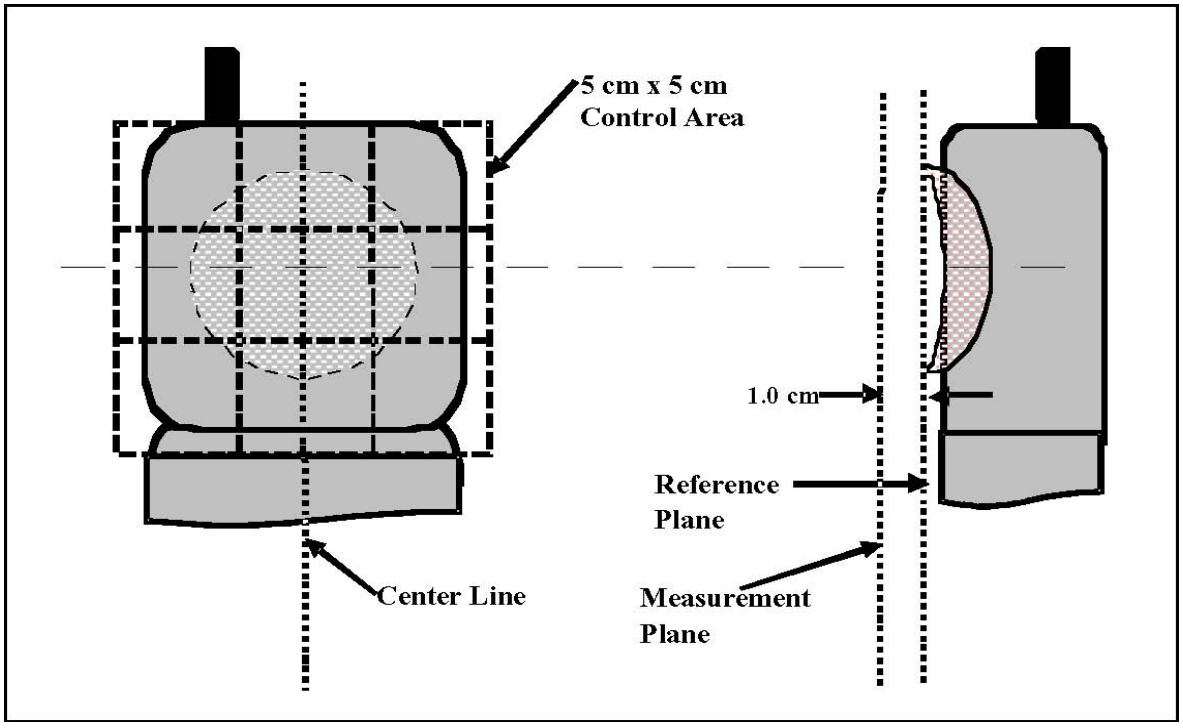
8. All results resulting from a measurement point in a T-Coil job were calculated from the signal samples during this window interval. ABM values were averaged over the sequence of these samples.
9. At an optimal point measurement, the SNR(ABM1/ABM2) was calculated for axial, radial transverse and radial longitudinal orientation, and the frequency response was measured in axial axis.
10. Corrected for the frequency response after the DUT measurement since the DASY5 system had known the spectrum of the input signal by using a reference job, as shown in the **appendix B2** of this report.
11. In SEMCAD post-processing, the spectral points are in addition scaled with the high-pass (half-band) and the A-weighting, bandwidth compensated factor (BWC) and those results are final as shown in this report.
12. Classified the signal quality based on the T-Coil Signal Quality Categories.

7. DESCRIPTION FOR EUT TESTING CONFIGURATION

The phone was tested in normal configurations for the ear use. The DASY5 measurement system specified in section 3.1 was utilized within the intended operations as set by the SPEAG™ setup. The Test Arch provided by SPEAG is used to position the DUT. All tests are done via conducted setup with CMU 200.

The distance is established by positioning the device beneath the test arch phantom so that it is touching the frame. The location and thickness of the arch, and the location/orientation of the coil within the probe housing, are precisely known values in the DASY software. The height of the measurement plane is further fine-tuned by performing a Surface Detection job at the beginning of each test. The end result is that the probe sensor is very precisely located 10mm above the device reference plane.





The following test configurations have been applied in this test report:

	
Test Setup Photo	**The testing configuration**

8. T-COIL REQUIREMENTS AND CATEGORY

8.1 RF EMISSIONS

EUT has to fulfill RF emission requirements at the axial measurement location.

8.2 AXIAL FIELD INTENSITY

The minimum limits of ABM1 field intensity shall be ≥ –18 dB (A/m) at 1 kHz, in a 1/3 octave band filter for all orientations.

8.3 SIGNAL QUALITY

Table 9.3 provides the signal quality requirement for the intended T-Coil signal from a Wireless Device. The worst Signal Quality of the axial and radial components of the magnetic field was used to determined the T-Coil category

Category	Telephone parameters WD signal quality [(signal + noise)-to-noise ratio in decibels]
Category T1	0 dB to 10 dB
Category T2	10 dB to 20 dB
Category T3	20 dB to 30 dB
Category T4	> 30 dB

8.4 FREQUENCY RESPONSE

The frequency response of the axial component must follow the frequency curve specified in ANSI C63.19-2007 section 7.3.3, over the frequency range 300-3000 Hz.

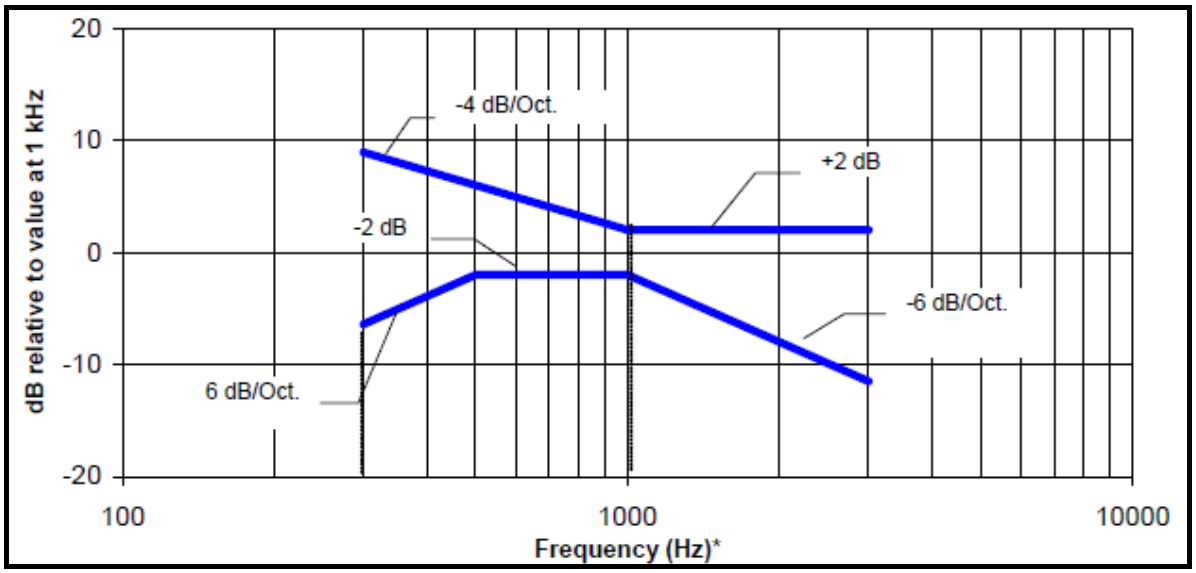


Figure 8.4a Magnetic field frequency response for WDs with a field ≤ –15 dB (A/m) at 1 kHz

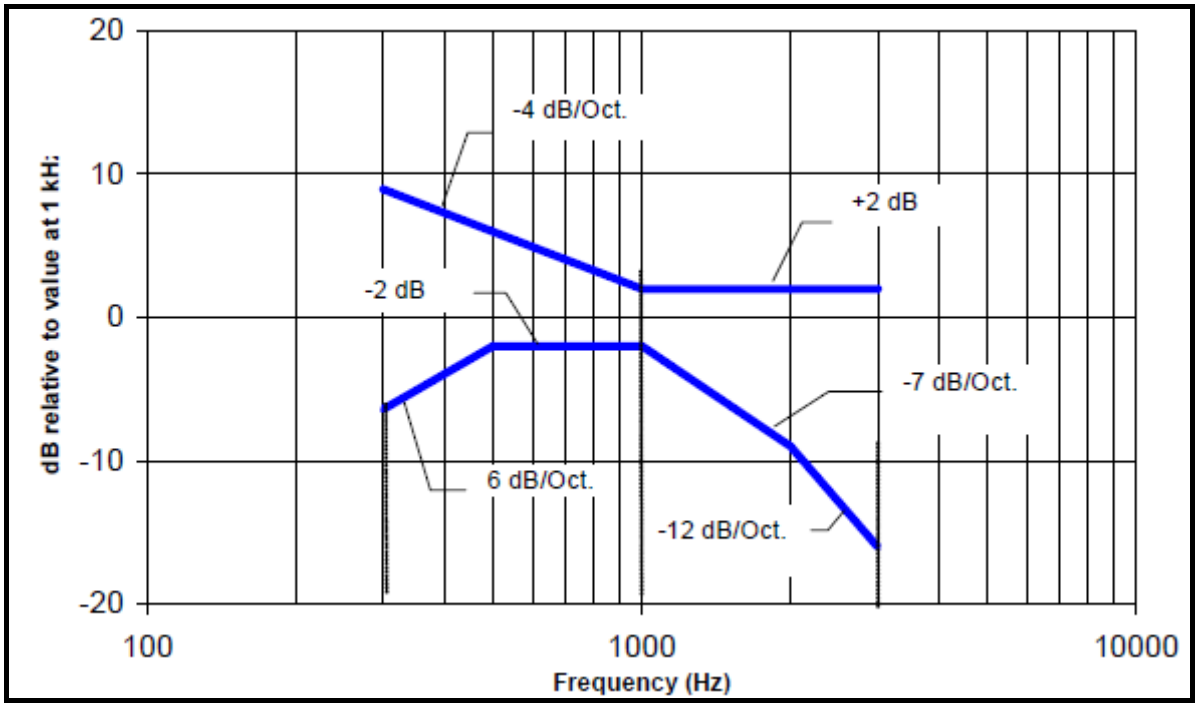


Figure 8.4b Magnetic field frequency response for WDs with a field that exceeds –15 dB(A/m) at 1 kHz

9. T-COIL TEST RESULT

9.1 SNR MEASUREMENT RESULT

For LCM brand: Auo

Probe Position	Band	Channel	Measurement Position (x mm, y mm)	Ambient Background Noise (dB A/m)	ABM2 (dB A/m)	ABM1 (dB A/m)	SNR (dB)	T-coil SNR Rating
Radial 1 (Longitudinal)	CDMA 850	384	6, 0	-55.02	-35.73	-7.33	28.4	T3
	CDMA 1900	1175	-6, -2	-54.82	-37.36	-6.36	31.0	T4
Radial2 (Transversal)	CDMA 850	384	0, -8	-54.71	-46.27	-7.67	38.6	T4
	CDMA 1900	1175	0, -6	-54.59	-44.21	-6.61	37.6	T4
Axial	CDMA 850	384	2, 0	-54.09	-29.82	0.39	30.2	T4
	CDMA 1900	1175	0, 0	-54.02	-31.87	0.03	31.9	T4

For LCM brand: EID

Probe Position	Band	Channel	Measurement Position (x mm, y mm)	Ambient Background Noise (dB A/m)	ABM2 (dB A/m)	ABM1 (dB A/m)	SNR (dB)	T-coil SNR Rating
Radial 1 (Longitudinal)	CDMA 850	384	4, 0	-54.10	-38.07	-7.67	30.4	T4
	CDMA 1900	1175	-6, -2	-54.81	-40.65	-5.85	34.8	T4
Radial2 (Transversal)	CDMA 850	384	0, -8	-53.87	-48.94	-6.44	42.5	T4
	CDMA 1900	1175	2, -6	-54.03	-49.52	-6.92	42.6	T4
Axial	CDMA 850	384	-2, 0	-53.43	-41.61	-0.21	41.4	T4
	CDMA 1900	1175	0, 0	-53.70	-42.35	2.05	44.4	T4

For LCM brand: Sharp

Probe Position	Band	Channel	Measurement Position (x mm, y mm)	Ambient Background Noise (dB A/m)	ABM2 (dB A/m)	ABM1 (dB A/m)	SNR (dB)	T-coil SNR Rating
Radial 1 (Longitudinal)	CDMA 850	1013	8, 2	-53.81	-40.2	-16.30	23.9	T3
		384	6, 2	-54.10	-33.70	-10.30	23.4	T3
		777	-8, -4	-53.43	-41.60	-14.40	27.2	T3
	CDMA 1900	25	-6, -4	-54.73	-40.05	-9.45	30.6	T4
		600	-6, 0	-54.88	-40.22	-8.62	31.6	T4
		1175	6, 0	-54.83	-39.20	-15.20	24.0	T3
Radial2 (Transversal)	CDMA 850	1013	2, -8	-54.10	-46.90	-15.50	31.4	T4
		384	0, -6	-53.87	-49.76	-9.06	40.7	T4
		777	0, -8	-54.02	-49.10	-14.80	34.3	T4
	CDMA 1900	25	-2, -8	-54.03	-45.90	-10.50	35.4	T4
		600	0, -8	-53.99	-48.62	-8.72	39.9	T4
		1175	2, -6	-54.02	-49.00	-15.60	33.4	T4
Axial	CDMA 850	1013	0, 0	-53.04	-41.61	-7.71	33.9	T4
		384	0, 0	-53.43	-31.11	-1.61	29.5	T3
		777	0, 0	-53.51	-40.89	-8.39	32.5	T4
	CDMA 1900	25	0, 0	-53.71	-41.225	-0.425	40.8	T4
		600	0, 0	-53.67	-40.84	-2.54	38.3	T4
		1175	0, 2	-53.63	-41.53	-5.93	35.6	T4

Remark:
Device operated condition:
The LCD backlight off, Bluetooth and WLAN functions are turn off, and volume is adjusted to maximum level , and microphone muted during T-Coil testing.

Table 9.1: Test Result for Various Positions

Note:

- Minimum Limit: ABM1 ≥-18 dB A/m
- Signal Quality = ABM1/ABM2
- Bold Number = worst case at each frequency band
- Data plots are showed in **appendix B1**

9.2 FREQUENCY RESPONSE AT AXIAL MEASUREMENT POINT

Cell Phone Mode	Verdict
CDMA 850	Pass
CDMA1900	Pass

Note: Please see **appendix B2** for the frequency response test raw data.

10. INFORMATION ON THE TESTING LABORATORIES

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

USA	FCC, NVLAP
GERMANY	TUV Rheinland
JAPAN	VCCI
NORWAY	NEMKO
CANADA	INDUSTRY CANADA, CSA
R.O.C.	TAF, BSMI, NCC
NETHERLANDS	Telefication
SINGAPORE	GOST-ASIA (MOU)
RUSSIA	CERTIS (MOU)

Copies of accreditation certificates of our laboratories obtained from approval agencies can be downloaded from our web site: www.adt.com.tw/index.5/phtml.
If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab:
Tel: 886-2-26052180
Fax: 886-2-26051924

Hsin Chu EMC/RF Lab:
Tel: 886-3-5935343
Fax: 886-3-5935342

Hwa Ya EMC/RF/Safety/Telecom Lab:
Tel: 886-3-3183232
Fax: 886-3-3185050

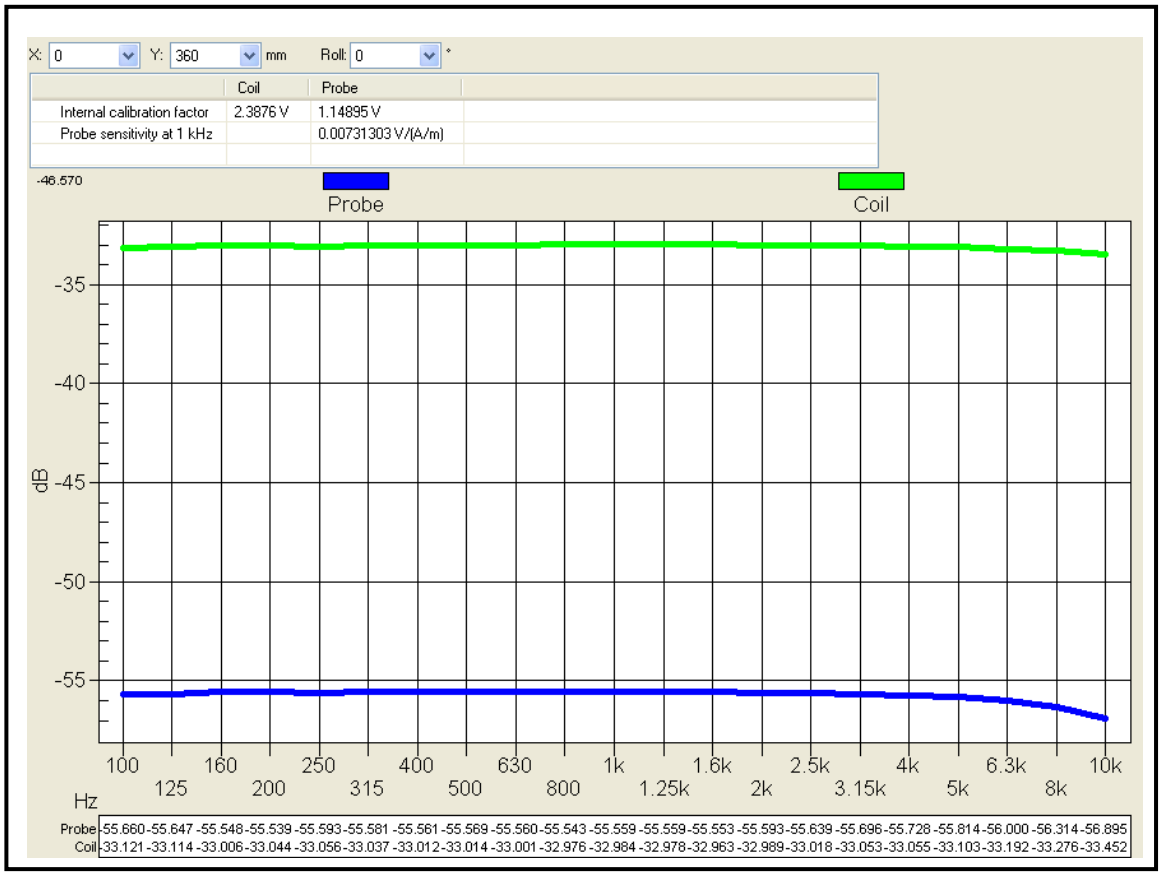
Web Site: www.adt.com.tw

The address and road map of all our labs can be found in our web site also.

---END---

APPENDIX A1:

Probe Calibration in AMCC



The frequency response and sensitivity of AM1D probe

APPENDIX A2:

Reference Input of Audio Signal Spectrum

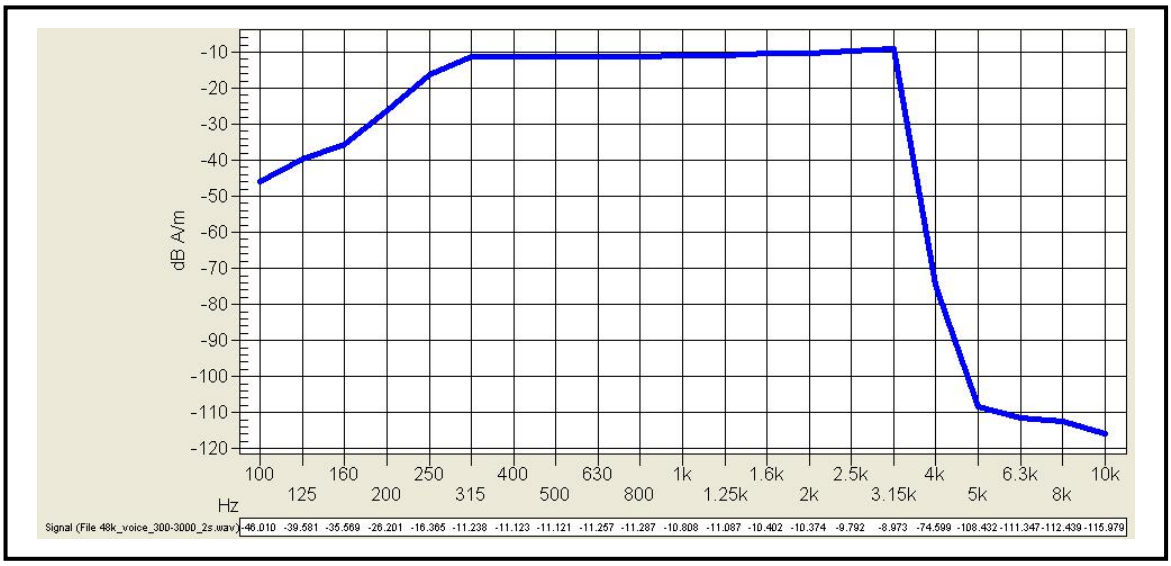


Figure A2-1: Audio signal spectrum of the broadband signal (48KHz_voice_300Hz~3KHz)

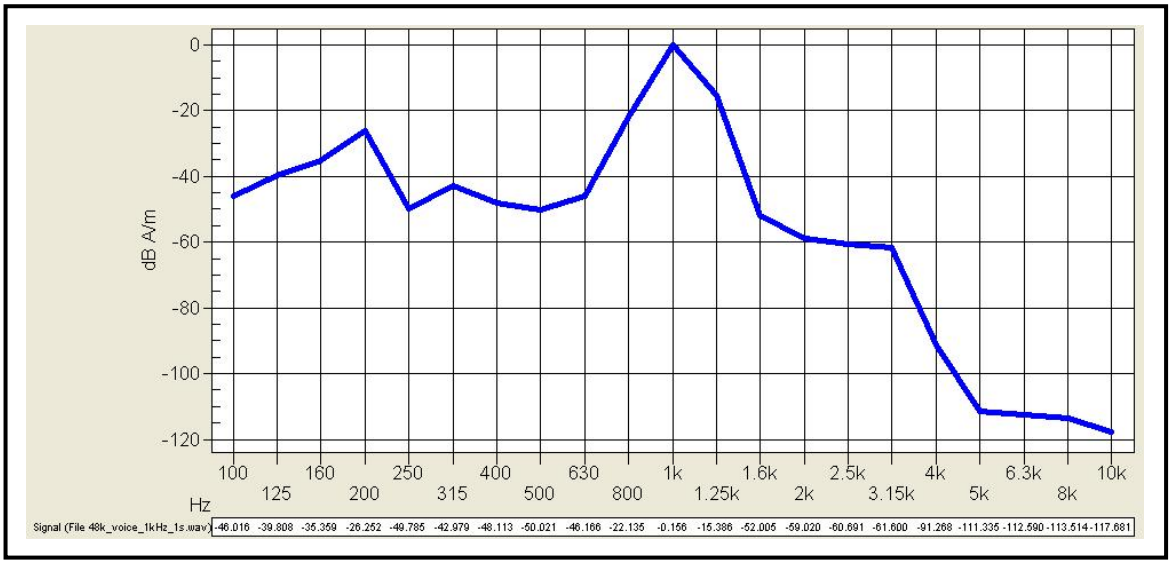
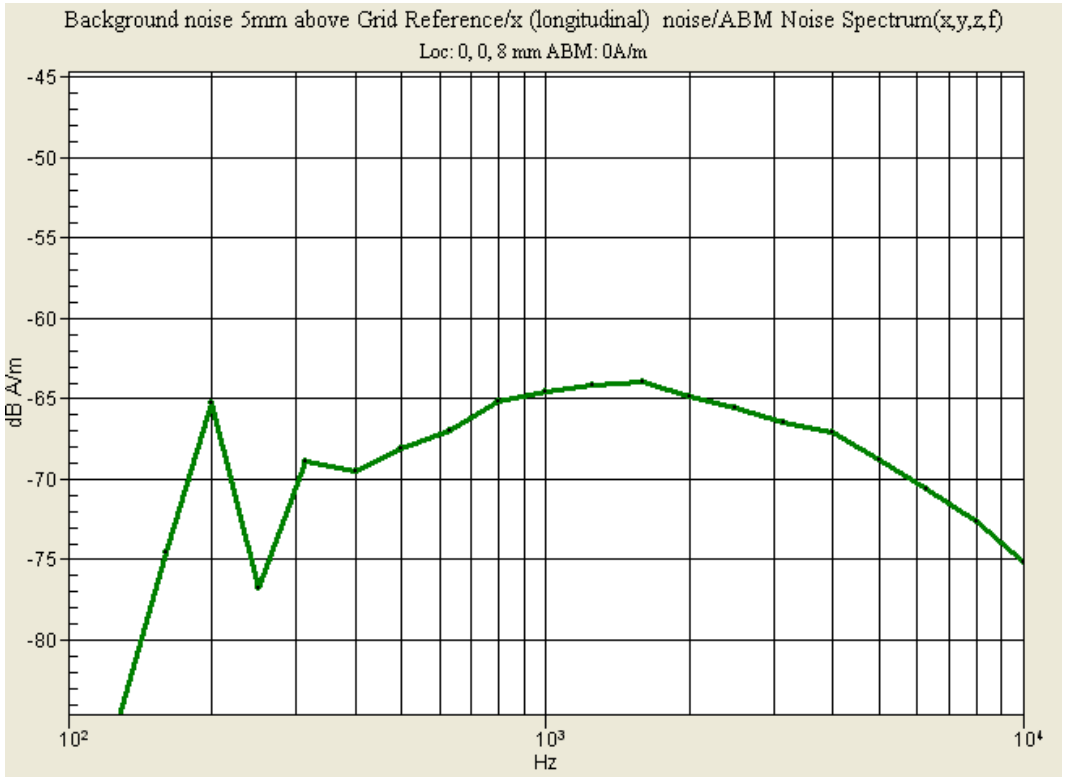


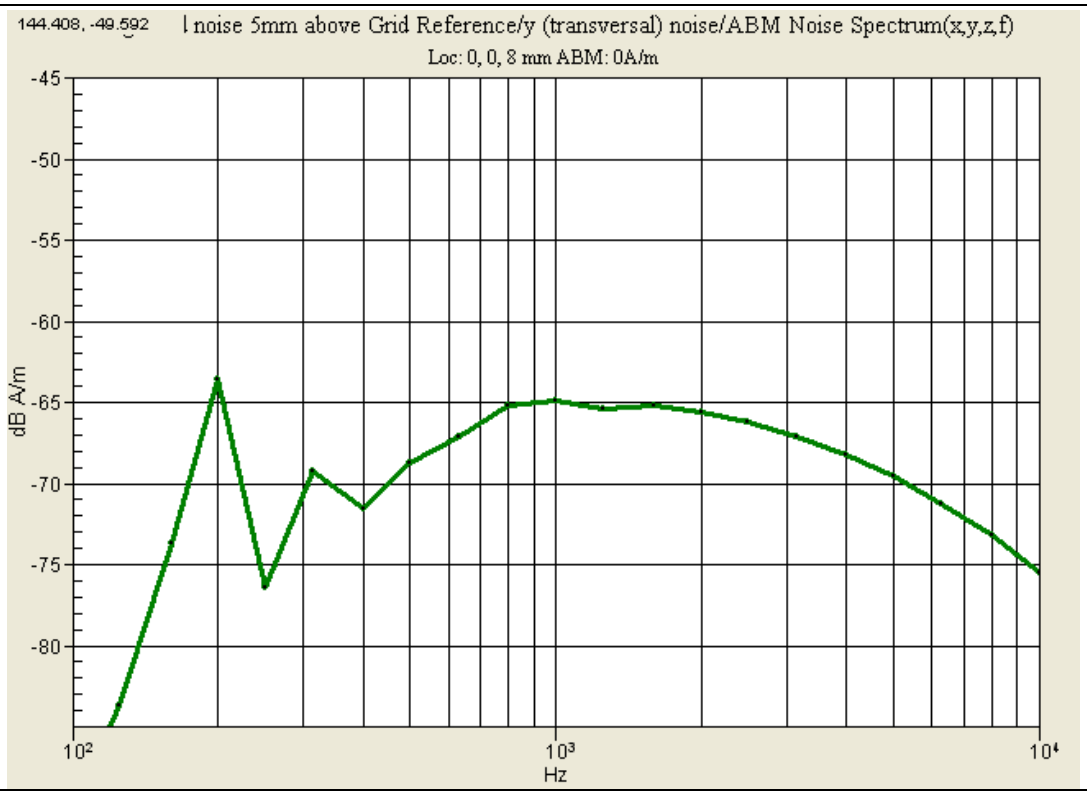
Figure A2-2: Audio signal spectrum of the narrowband signal (48KHz_voice_1KHz)

APPENDIX A3:

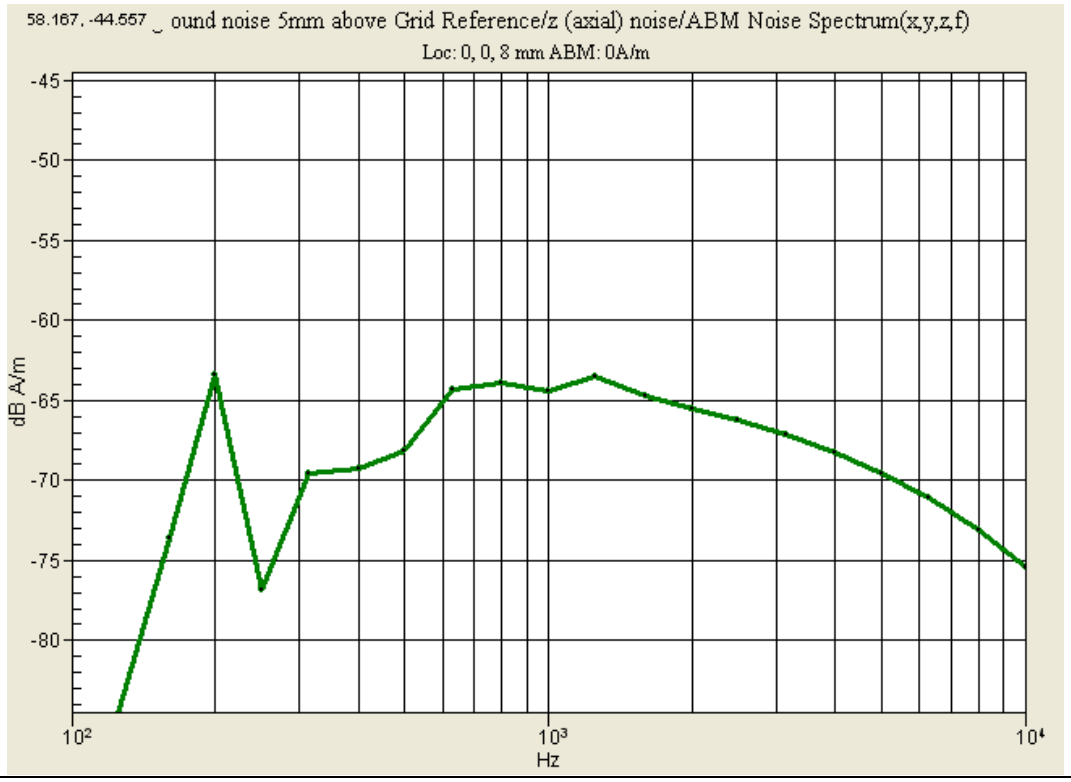
Ambient Noise Spectrum Plots



Radial 1 Position Ambient Noise Spectrum Plot



Radial 2 Position Ambient Noise Spectrum Plot



Axial Position Ambient Noise Spectrum Plot

APPENDIX B1:

SNR Test Plots
RHOD500-3rd

Date/Time: 2009/3/17 09:42:15

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH1013_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 824.7 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -19.9 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

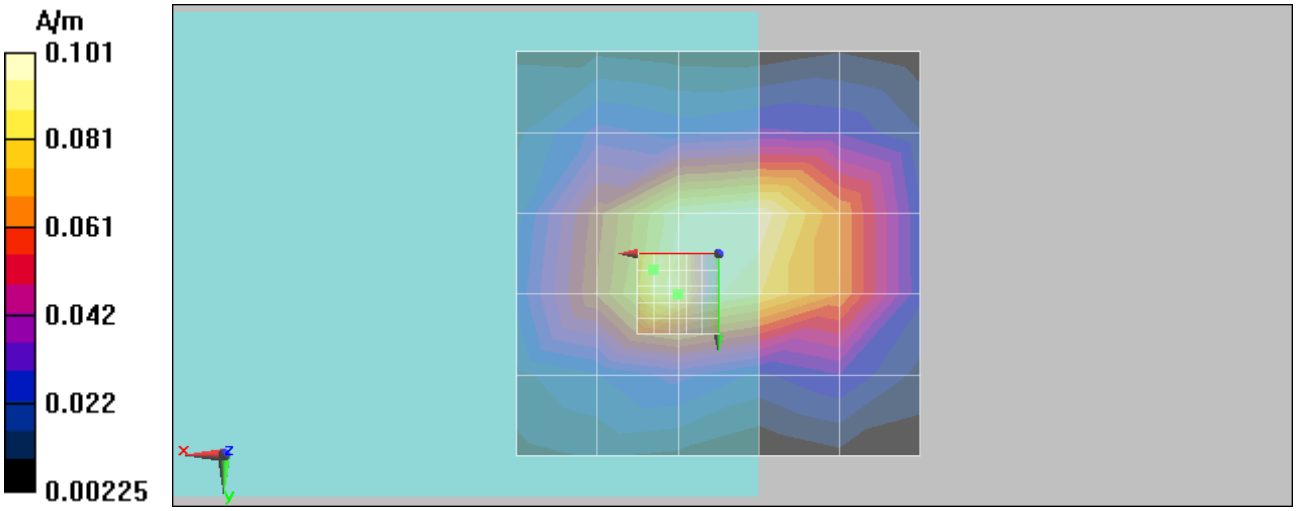
Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -16.9 dB A/m
BWC Factor = 0.157003 dB
Location: 8, 2, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 23.9 dB
ABM1 comp = -16.3 dB A/m
BWC Factor = 0.155041 dB
Location: 8, 2, 3 mm



Date/Time: 2009/3/17 10:12:25

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.98 dB A/m
BWC Factor = 0.155979 dB
Location: 5, 5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

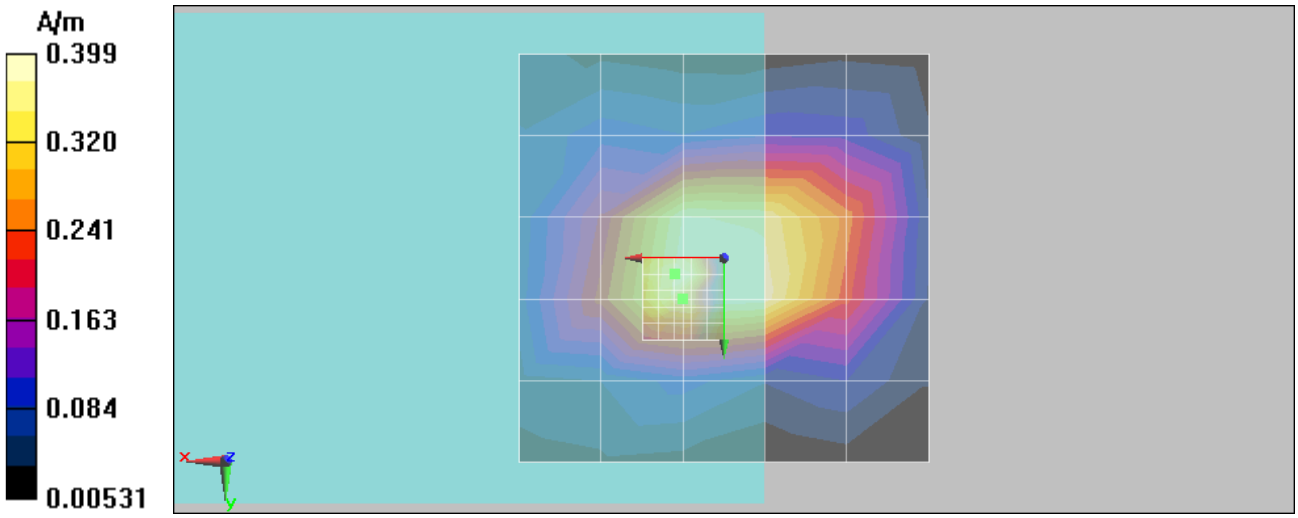
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.33 dB A/m
BWC Factor = 0.155979 dB
Location: 6, 2, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 23.4 dB
ABM1 comp = -10.3 dB A/m
BWC Factor = 0.157003 dB
Location: 6, 2, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH777_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 848.3 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -16.6 dB A/m
BWC Factor = 0.157003 dB
Location: -5, -5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

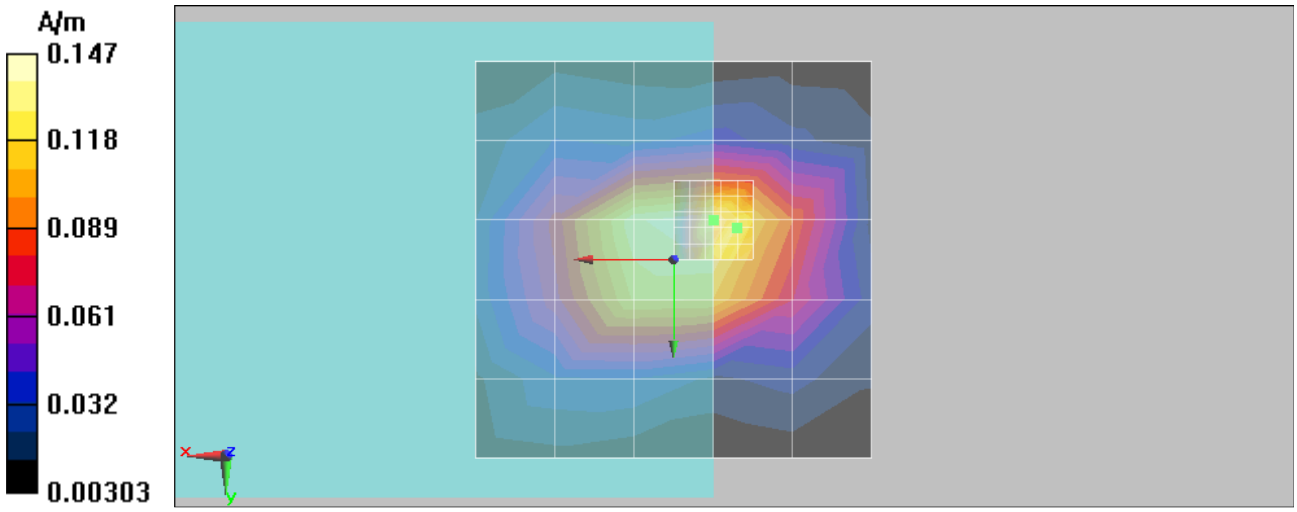
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -15.2 dB A/m
BWC Factor = 0.155979 dB
Location: -8, -4, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 27.2 dB
ABM1 comp = -14.4 dB A/m
BWC Factor = 0.155979 dB
Location: -8, -4, 3 mm



Date/Time: 2009/3/17 11:22:09

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH25_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 1851.25 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.8 dB A/m
BWC Factor = 0.155979 dB
Location: -5, -5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

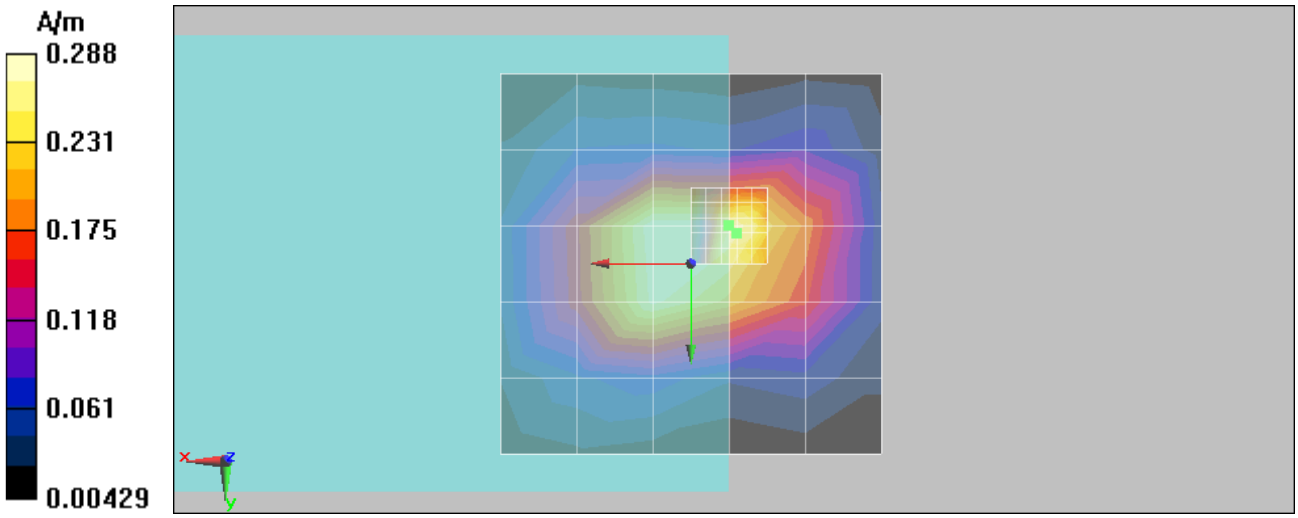
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.158027 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -9.92 dB A/m
BWC Factor = 0.158027 dB
Location: -6, -4, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 30.6 dB
ABM1 comp = -9.45 dB A/m
BWC Factor = 0.155979 dB
Location: -6, -4, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH600_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.8 dB A/m
BWC Factor = 0.155979 dB
Location: -5, 5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

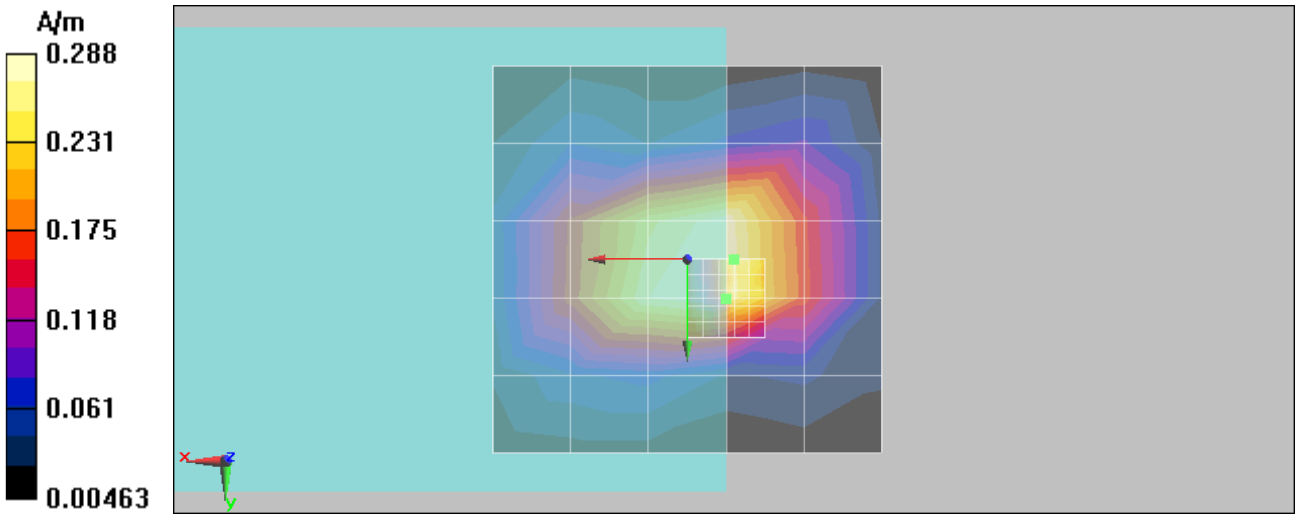
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -8.67 dB A/m
BWC Factor = 0.155979 dB
Location: -6, 0, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 31.6 dB
ABM1 comp = -8.62 dB A/m
BWC Factor = 0.155979 dB
Location: -6, 0, 3 mm



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Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -17.2 dB A/m
BWC Factor = 0.155979 dB
Location: 5, 5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

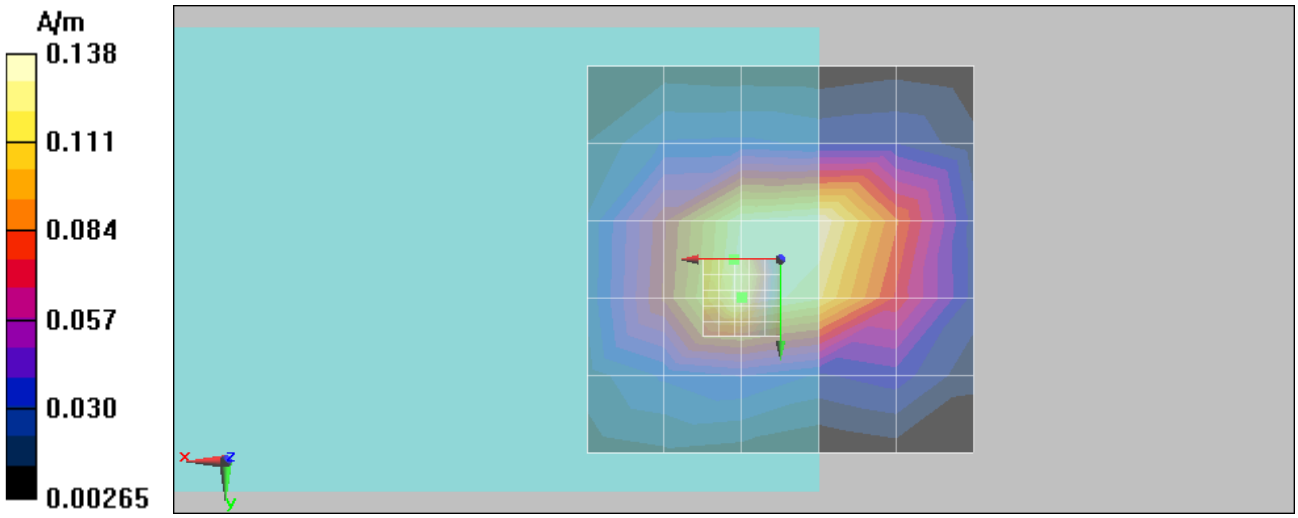
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -15.4 dB A/m
BWC Factor = 0.155979 dB
Location: 6, 0, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 24 dB
ABM1 comp = -15.2 dB A/m
BWC Factor = 0.155041 dB
Location: 6, 0, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH1013_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 824.7 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -21 dB A/m
BWC Factor = 0.155041 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

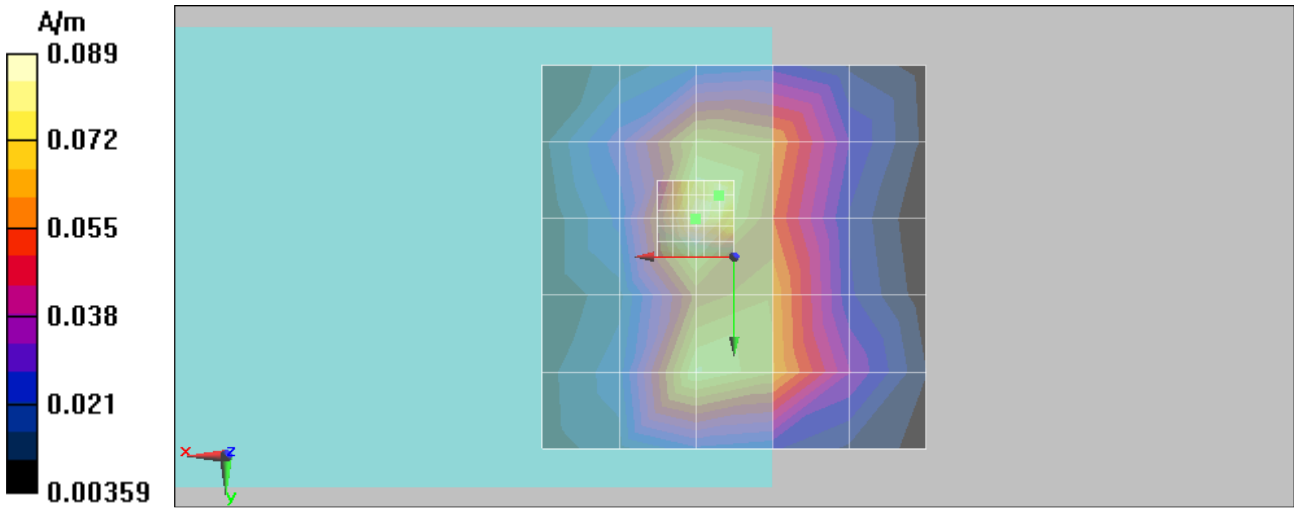
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -16.2 dB A/m
BWC Factor = 0.157003 dB
Location: 2, -8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 31.4 dB
ABM1 comp = -15.5 dB A/m
BWC Factor = 0.155041 dB
Location: 2, -8, 3 mm



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Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -8.82 dB A/m
BWC Factor = 0.155979 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

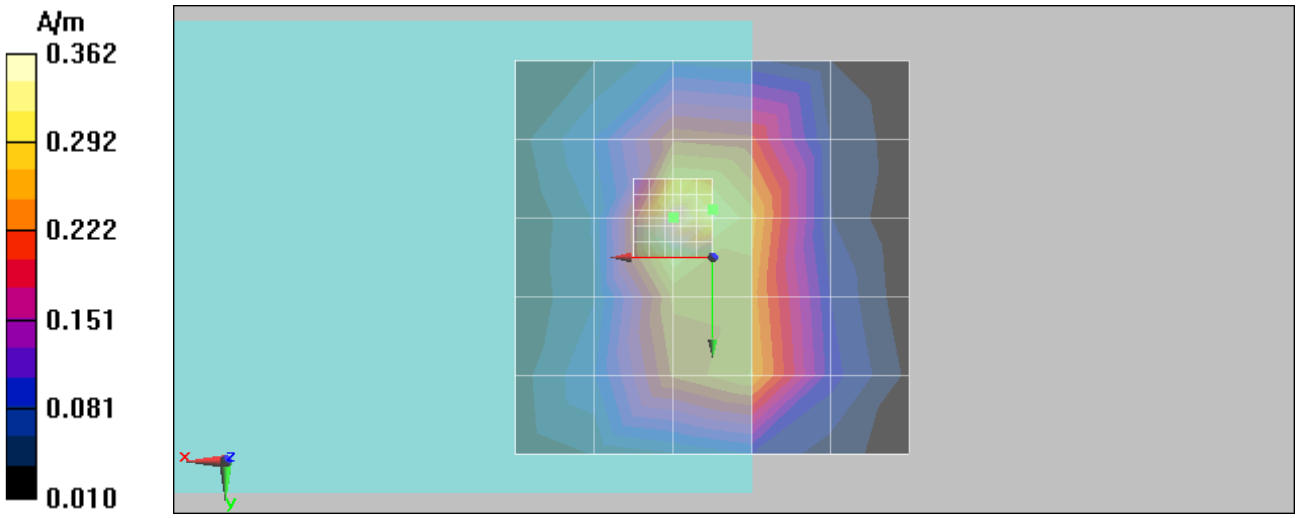
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -9.85 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -6, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 40.7 dB
ABM1 comp = -9.06 dB A/m
BWC Factor = 0.157003 dB
Location: 0, -6, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH777_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 848.3 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -17.4 dB A/m
BWC Factor = 0.157003 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

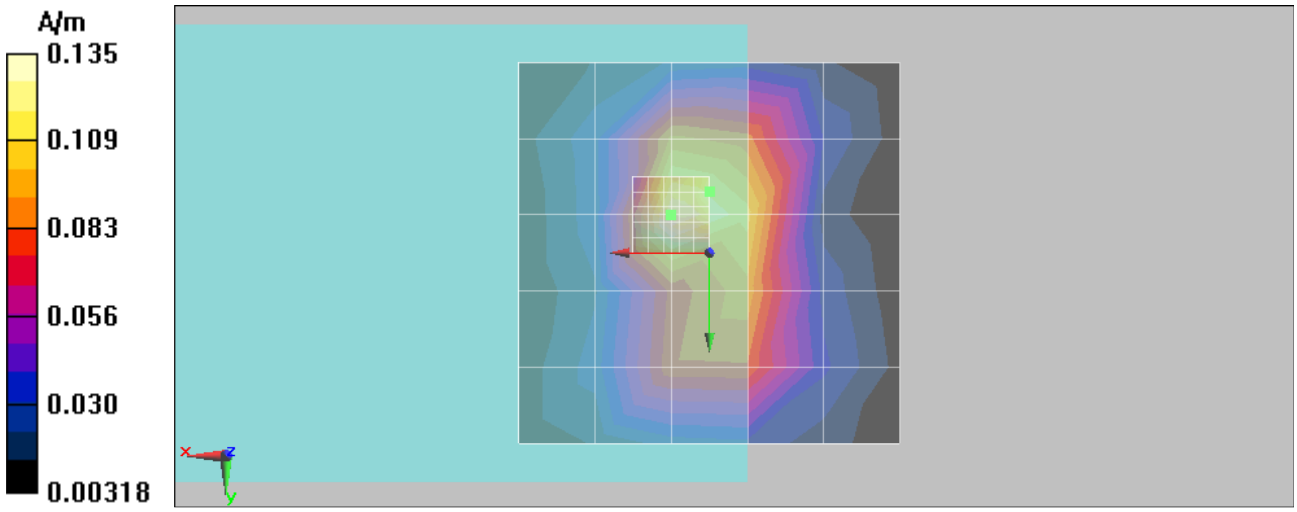
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -15.4 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 34.3 dB
ABM1 comp = -14.8 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -8, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH25_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 1851.25 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -12.7 dB A/m
BWC Factor = 0.155979 dB
Location: -5, 5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

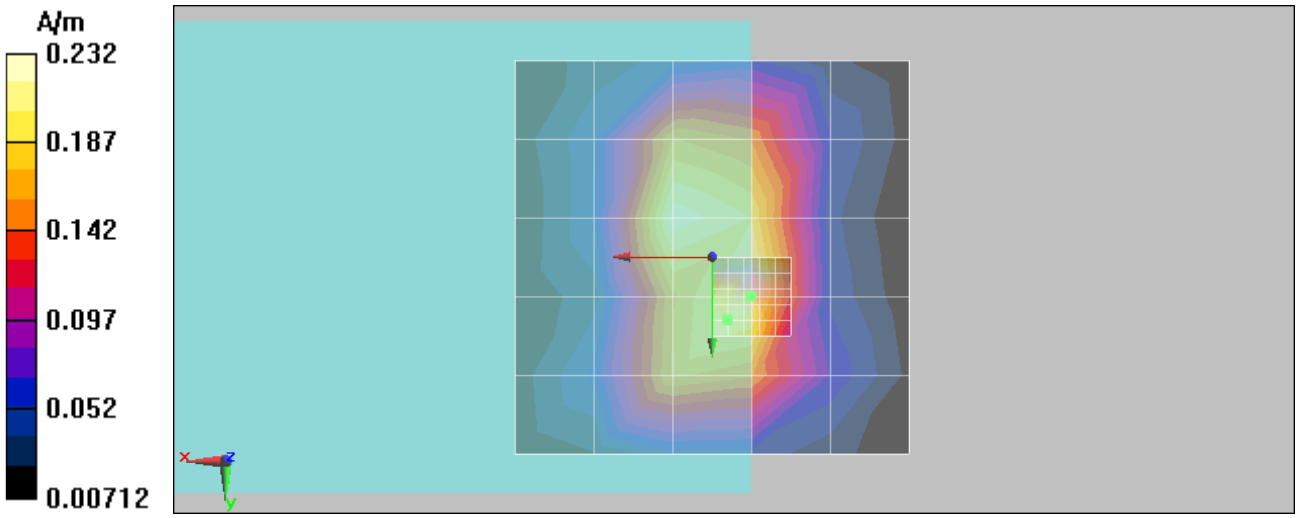
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.158027 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.65 dB A/m
BWC Factor = 0.158027 dB
Location: -2, 8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 35.4 dB
ABM1 comp = -10.5 dB A/m
BWC Factor = 0.155979 dB
Location: -2, 8, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH600_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -12.3 dB A/m
BWC Factor = 0.155979 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

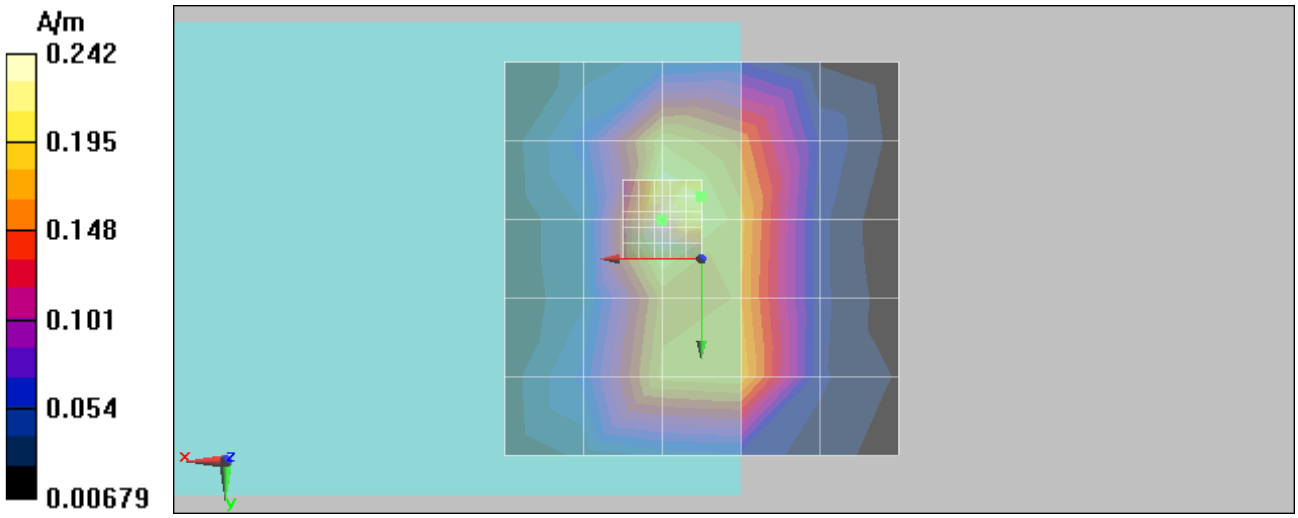
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -9.31 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 39.9 dB
ABM1 comp = -8.72 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -8, 3 mm



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Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -17.4 dB A/m
BWC Factor = 0.155979 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

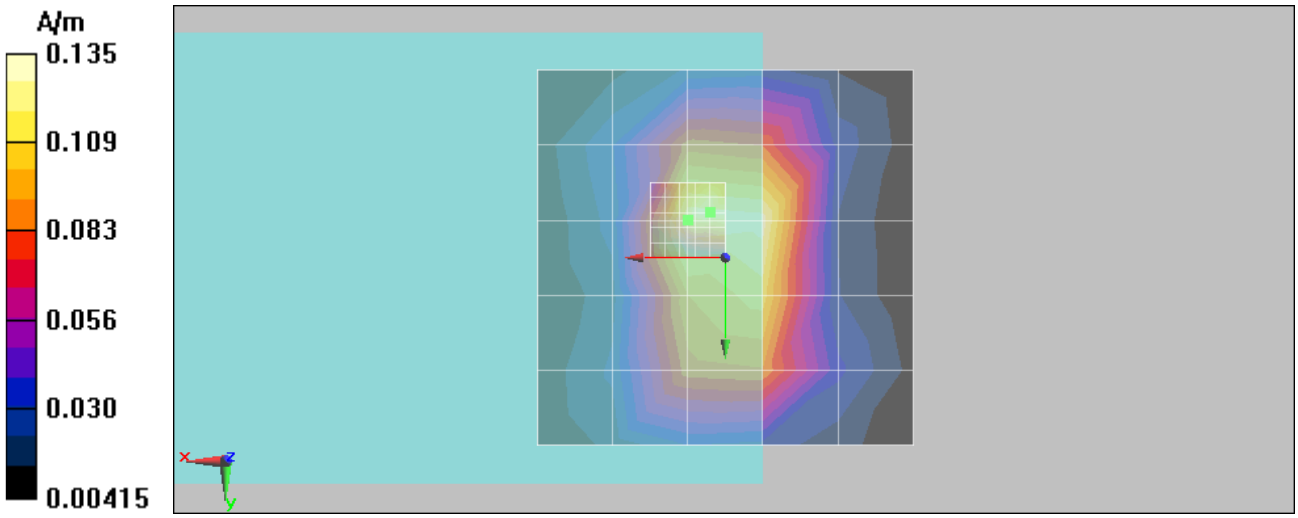
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -15.7 dB A/m
BWC Factor = 0.155979 dB
Location: 2, -6, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 33.4 dB
ABM1 comp = -15.6 dB A/m
BWC Factor = 0.155041 dB
Location: 2, -6, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH1013_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 824.7 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -14.9 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.82 dB A/m
BWC Factor = 0.157003 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

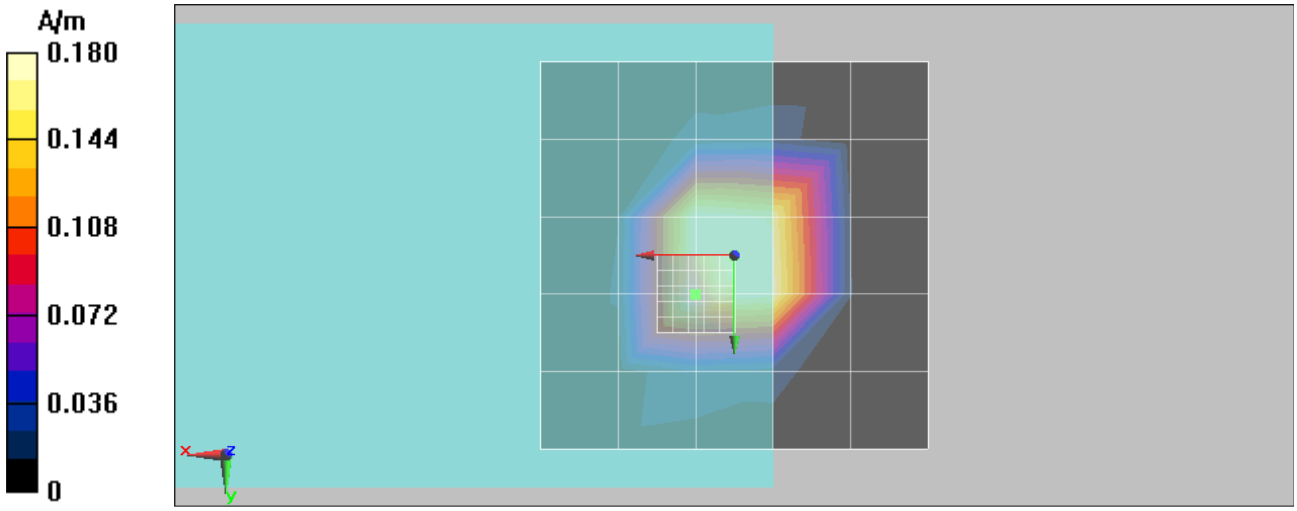
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 33.9 dB
ABM1 comp = -7.71 dB A/m
BWC Factor = 0.155041 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 37 dB
ABM1 comp = -4.66 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -4.21 dB A/m
BWC Factor = 0.155979 dB
Location: 5, -5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -1.692 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

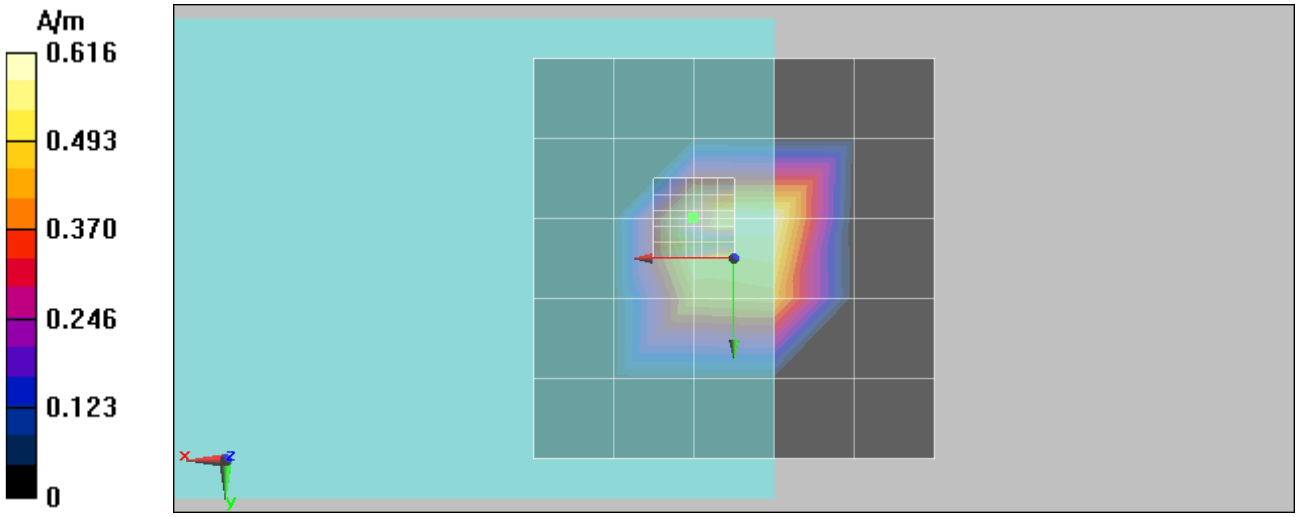
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 29.5 dB
ABM1 comp = -1.61 dB A/m
BWC Factor = 0.157003 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 33.1 dB
ABM1 comp = 2.02 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH777_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 848.3 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -13.6 dB A/m
BWC Factor = 0.157003 dB
Location: 5, -5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -8.57 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

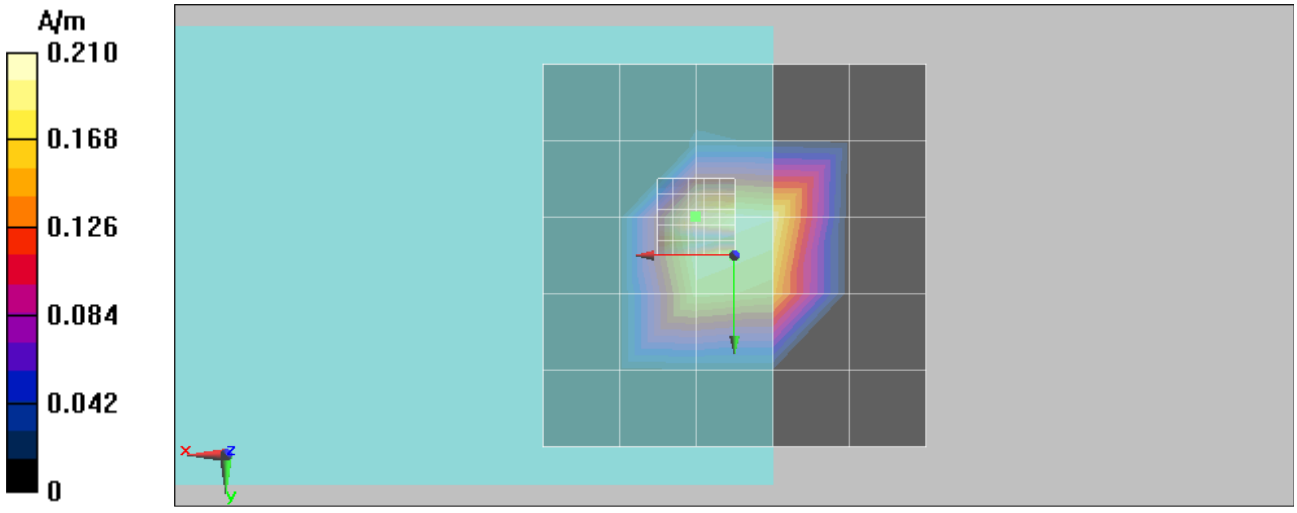
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 32.5 dB
ABM1 comp = -8.39 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 38.3 dB
ABM1 comp = -2.68 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



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Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH25_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 1851.25 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.39 dB A/m
BWC Factor = 0.155979 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.158027 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -0.434 dB A/m
BWC Factor = 0.158027 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

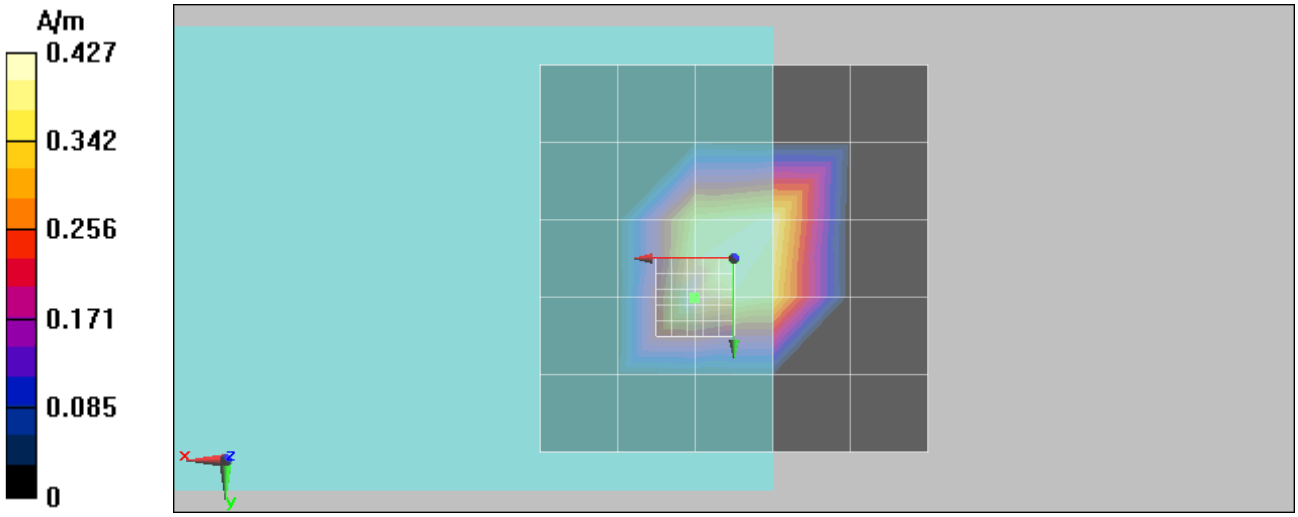
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 40.8 dB
ABM1 comp = -0.425 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 44.8 dB
ABM1 comp = 3.57 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH600_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 1880 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -8.07 dB A/m
BWC Factor = 0.155979 dB
Location: 5, -5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -2.56 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

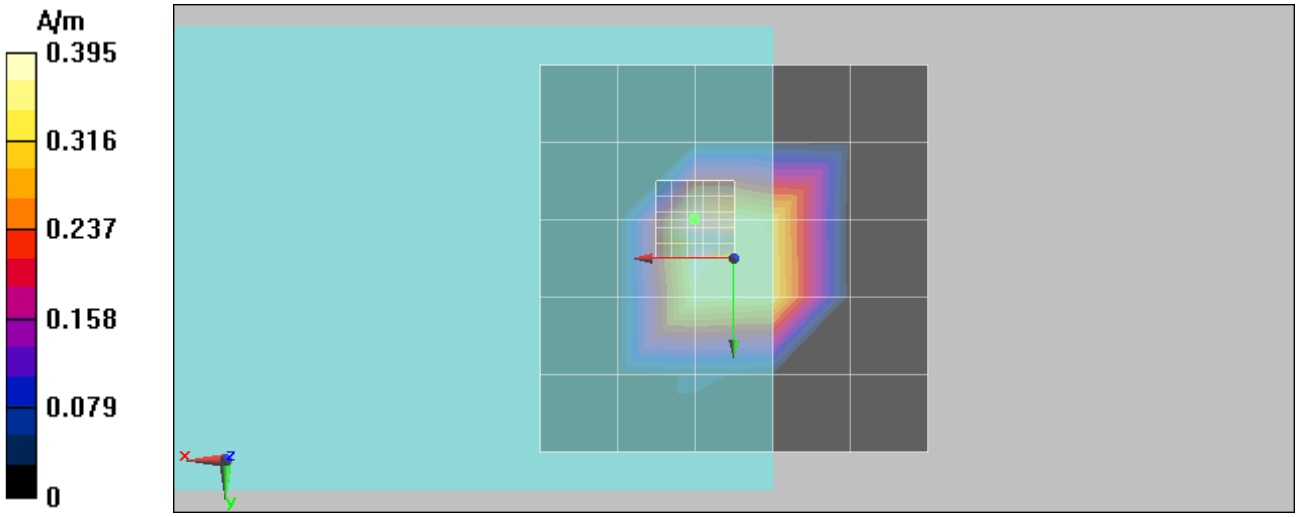
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 38.3 dB
ABM1 comp = -2.54 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 44 dB
ABM1 comp = 3.31 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



Date/Time: 2009/3/17 01:46:42

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -12.6 dB A/m
BWC Factor = 0.155979 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -6.06 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 2, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

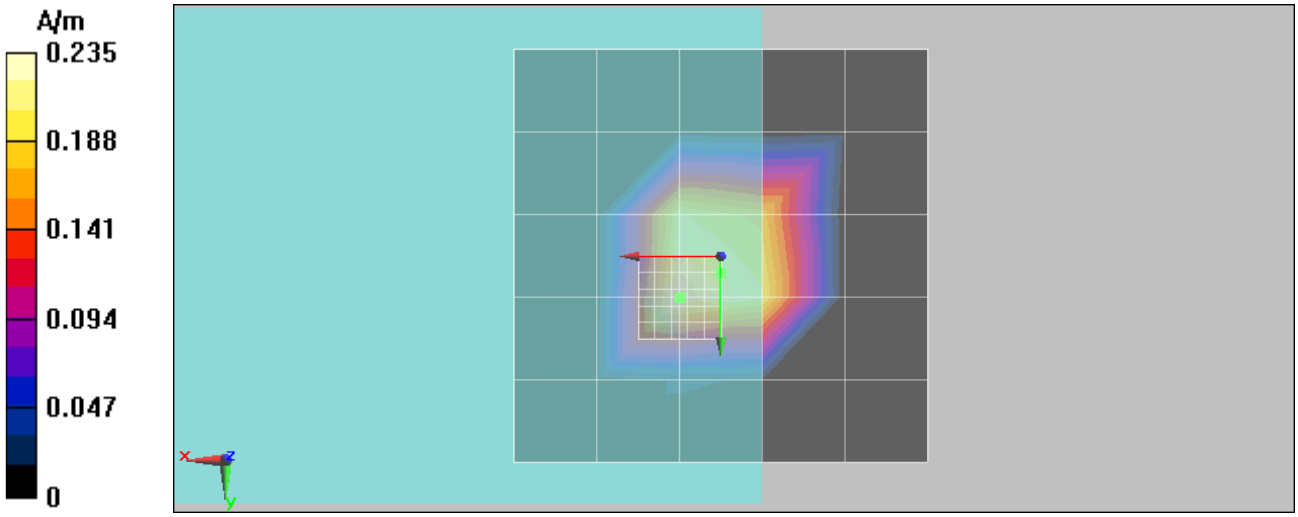
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 35.6 dB
ABM1 comp = -5.93 dB A/m
BWC Factor = 0.155041 dB
Location: 0, 2, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 36.9 dB
ABM1 comp = -4.43 dB A/m
BWC Factor = 10.8 dB
Location: 0, 2, 3 mm



RHOD500-1st

Date/Time: 2009/3/16 01:41:46

Test Laboratory: BV-ADT

T-Coil CDMA850 Ch384_Radial 1

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -8.3 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

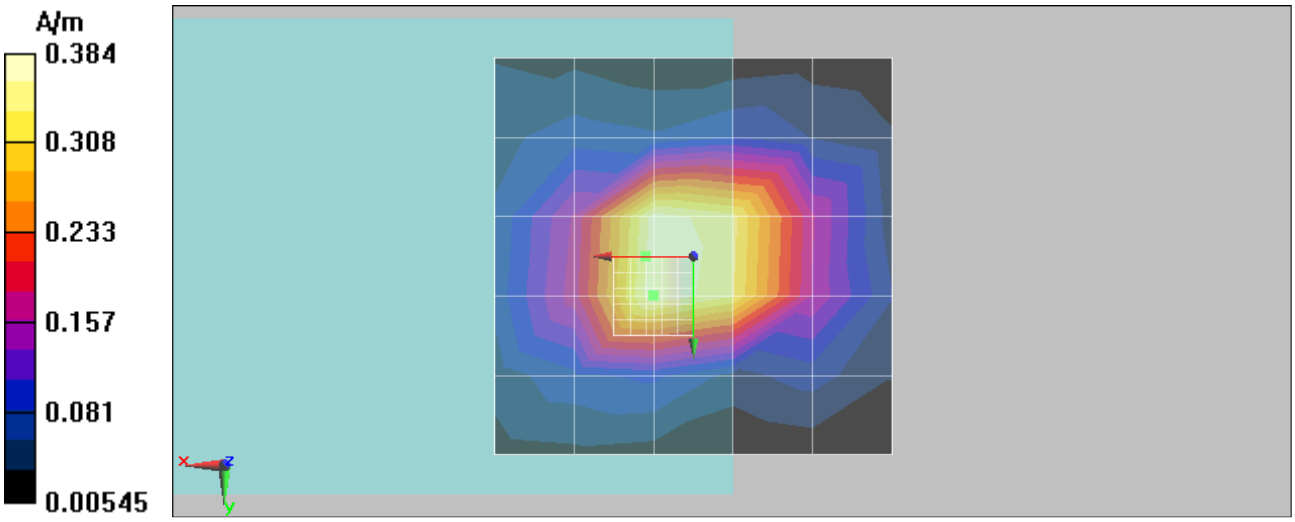
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.44 dB A/m
BWC Factor = 0.155041 dB
Location: 6, 0, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 28.4 dB
ABM1 comp = -7.33 dB A/m
BWC Factor = 0.155041 dB
Location: 6, 0, 3 mm



Test Laboratory: BV-ADT

T-Coil CDMA1900 Ch1175_Radial 1

DUT: RHOD 500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.47 dB A/m
BWC Factor = 0.155041 dB
Location: -5, -5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.154017 dB
Device Reference Point: 0, 0, -6.3 mm

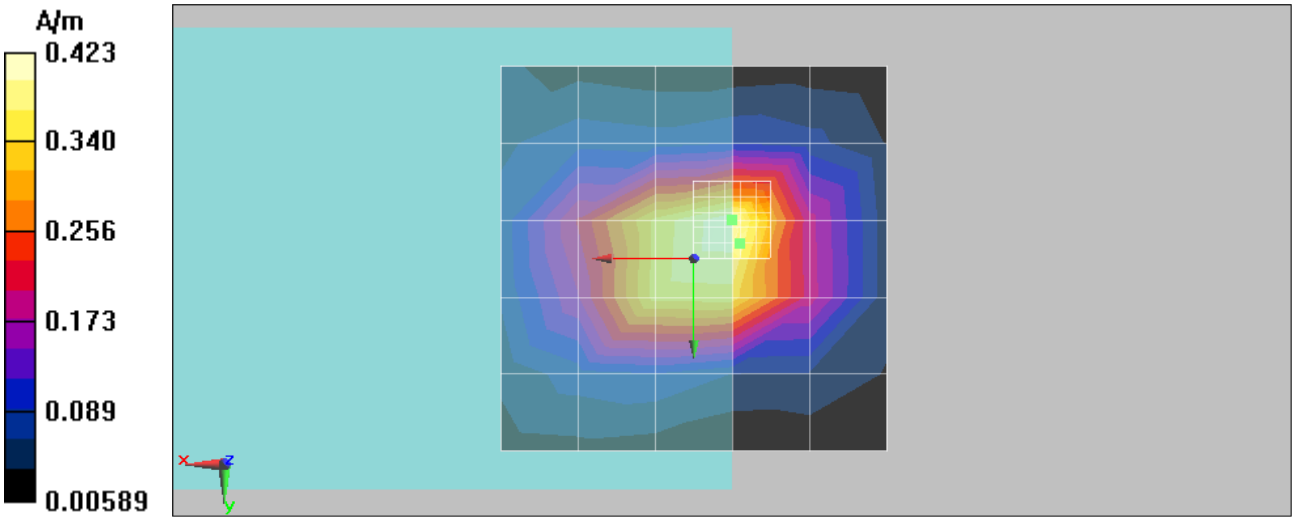
Cursor:
ABM1 comp = -6.52 dB A/m
BWC Factor = 0.154017 dB
Location: -6, -2, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 31 dB
ABM1 comp = -6.36 dB A/m
BWC Factor = 0.155979 dB
Location: -6, -2, 3 mm



Test Laboratory: BV-ADT

T-Coil CDMA850 Ch384_Radial 2

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -9.22 dB A/m
BWC Factor = 0.155041 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

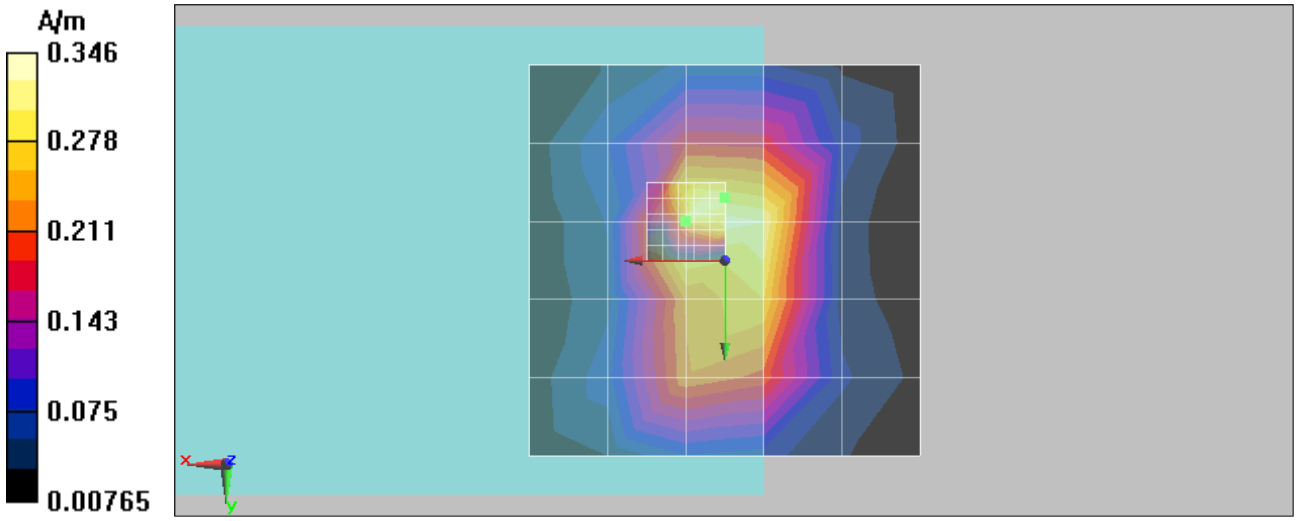
Cursor:
ABM1 comp = -7.84 dB A/m
BWC Factor = 0.155041 dB
Location: 0, -8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 38.6 dB
ABM1 comp = -7.67 dB A/m
BWC Factor = 0.155041 dB
Location: 0, -8, 3 mm



Date/Time: 2009/3/16 02:23:49

Test Laboratory: BV-ADT

T-Coil CDMA1900 Ch1175_Radial 2

DUT: RHOD 500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.1 dB A/m
BWC Factor = 0.155041 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.154017 dB
Device Reference Point: 0, 0, -6.3 mm

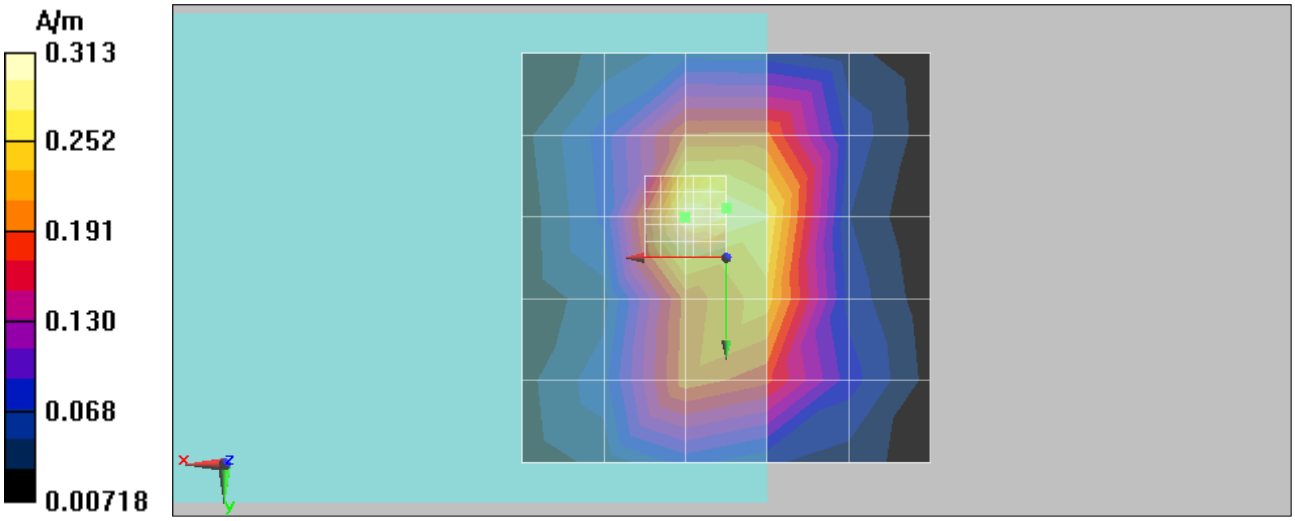
Cursor:
ABM1 comp = -6.79 dB A/m
BWC Factor = 0.154017 dB
Location: 0, -6, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 37.6 dB
ABM1 comp = -6.61 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -6, 3 mm



Date/Time: 2009/3/16 01:40:10

Test Laboratory: BV-ADT

T-Coil CDMA850 Ch384_Axial

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -5.83 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = 0.09 dB A/m
BWC Factor = 0.155041 dB
Location: 2, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

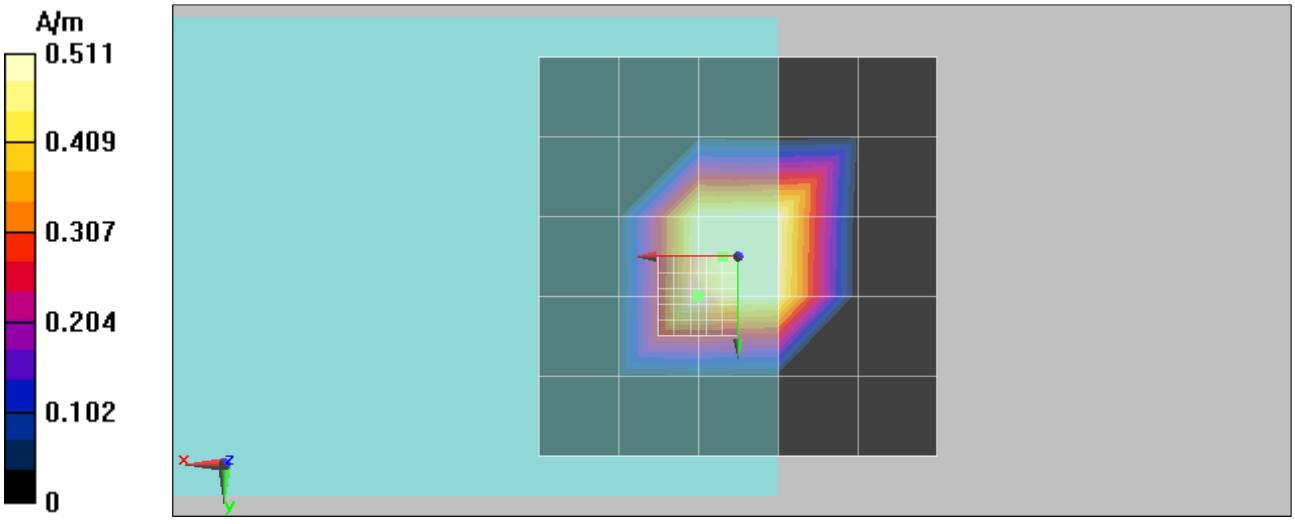
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 30.2 dB
ABM1 comp = 0.385 dB A/m
BWC Factor = 0.155041 dB
Location: 2, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 33.5 dB
ABM1 comp = 3.62 dB A/m
BWC Factor = 10.8 dB
Location: 2, 0, 3 mm



Test Laboratory: BV-ADT

T-Coil CDMA1900 Ch1175_Axial

DUT: RHOD 500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY4 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -5.19 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.154017 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -0.24 dB A/m
BWC Factor = 0.154017 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav

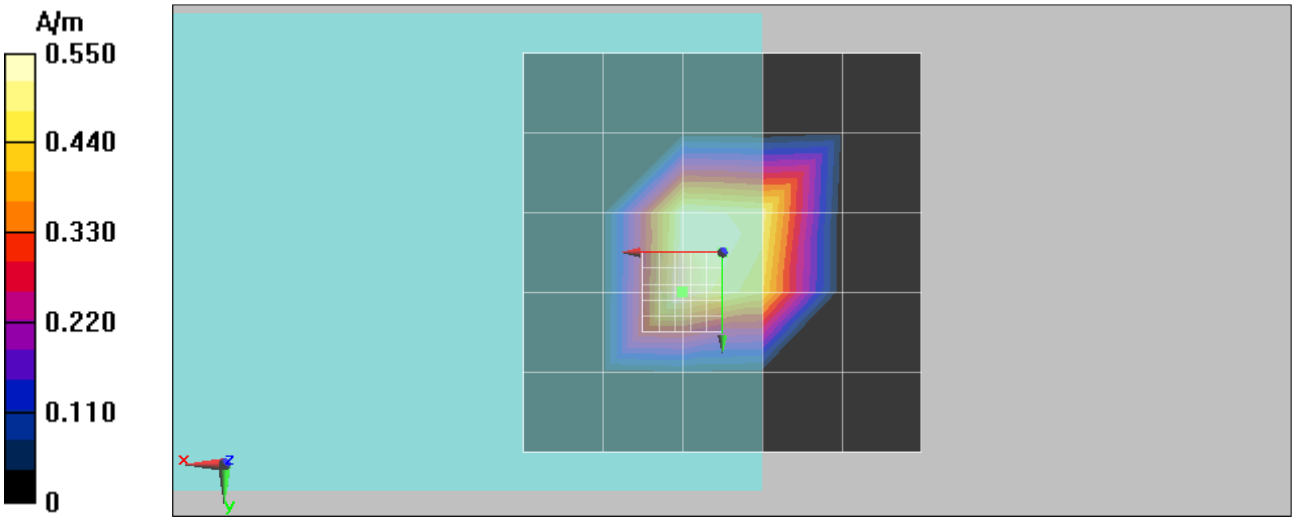
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 31.9 dB
ABM1 comp = 0.029 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 37 dB
ABM1 comp = 5.15 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm



RHOD500-2nd

Date/Time: 2009/3/16 03:07:34

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_RADIAL 1

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.89 dB A/m
BWC Factor = 0.157003 dB
Location: 5, -5, 3 mm

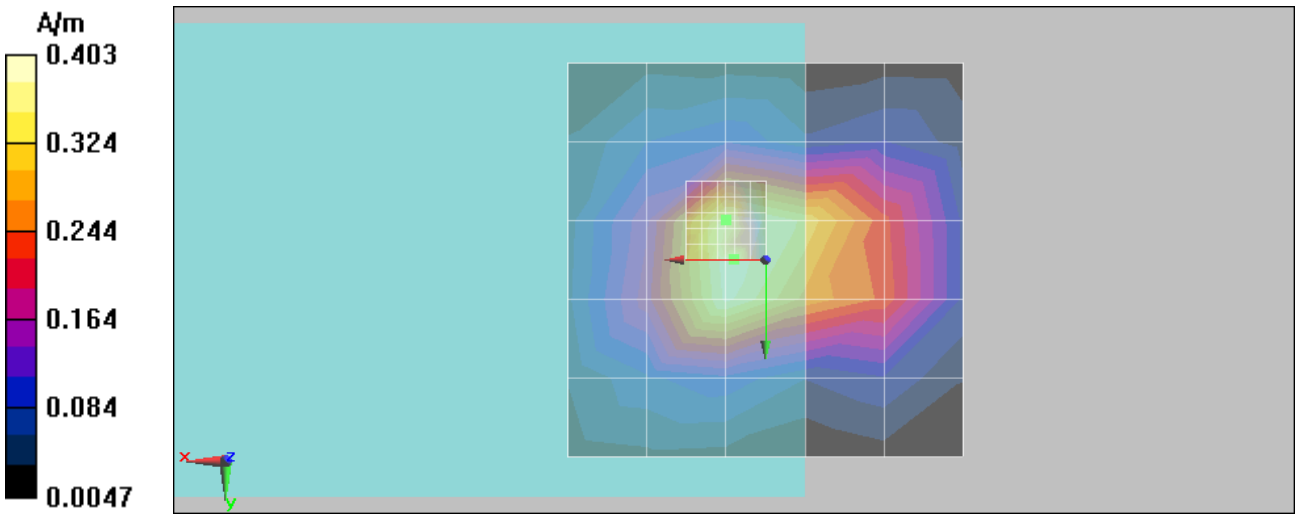
Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.91 dB A/m
BWC Factor = 0.157003 dB
Location: 4, 0, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 30.4 dB
ABM1 comp = -7.67 dB A/m
BWC Factor = 0.155979 dB
Location: 4, 0, 3 mm



Date/Time: 2009/3/16 04:40:05

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_RADIAL 1

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/x (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.09 dB A/m
BWC Factor = 0.155041 dB
Location: -5, -5, 3 mm

Fine scan/x (longitudinal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

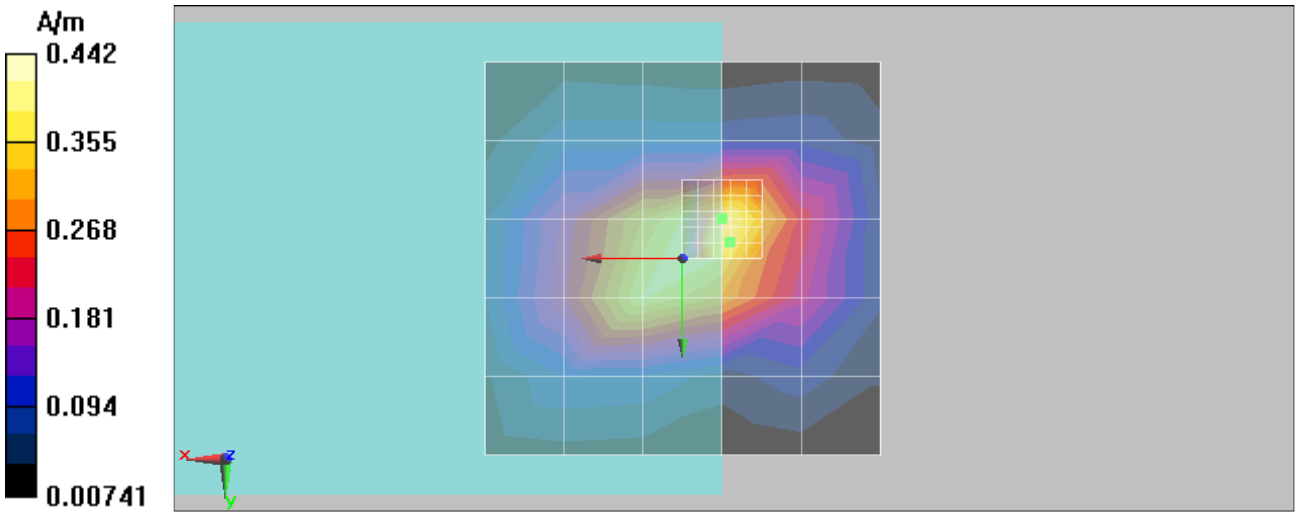
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -6.18 dB A/m
BWC Factor = 0.155979 dB
Location: -6, -2, 3 mm

Point scan/x (longitudinal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 34.8 dB
ABM1 comp = -5.85 dB A/m
BWC Factor = 0.155979 dB
Location: -6, -2, 3 mm



Date/Time: 2009/3/16 03:08:03

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_RADIAL 2

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -9.45 dB A/m
BWC Factor = 0.157003 dB
Location: -5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

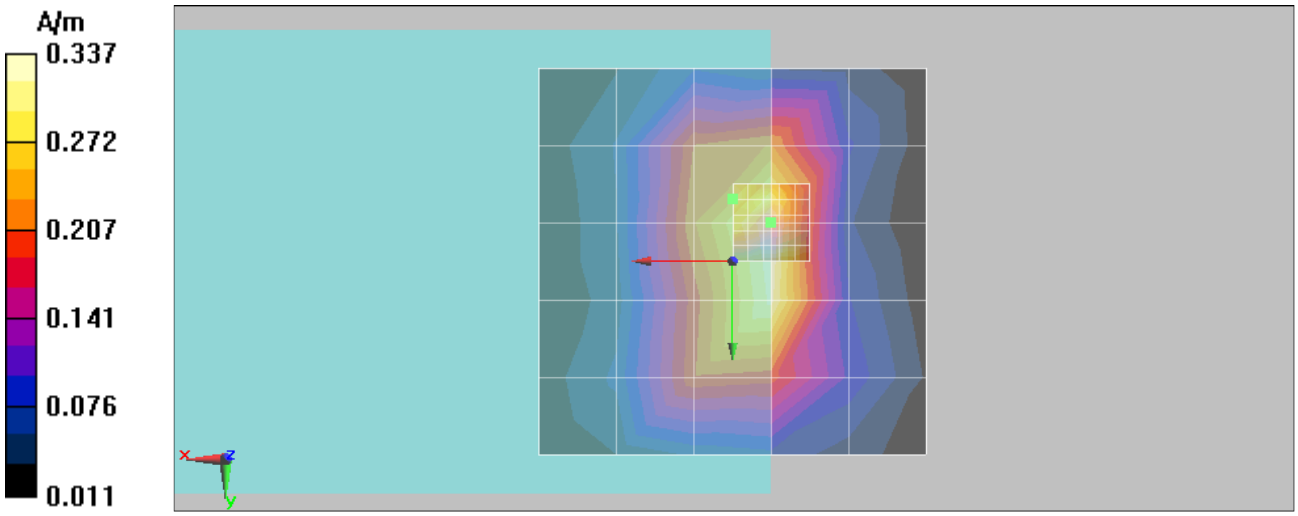
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -6.64 dB A/m
BWC Factor = 0.157003 dB
Location: 0, -8, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 42.5 dB
ABM1 comp = -6.44 dB A/m
BWC Factor = 0.155979 dB
Location: 0, -8, 3 mm



Date/Time: 2009/3/16 04:41:34

Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_RADIAL 2

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/y (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -10.7 dB A/m
BWC Factor = 0.155041 dB
Location: 5, -5, 3 mm

Fine scan/y (transversal) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

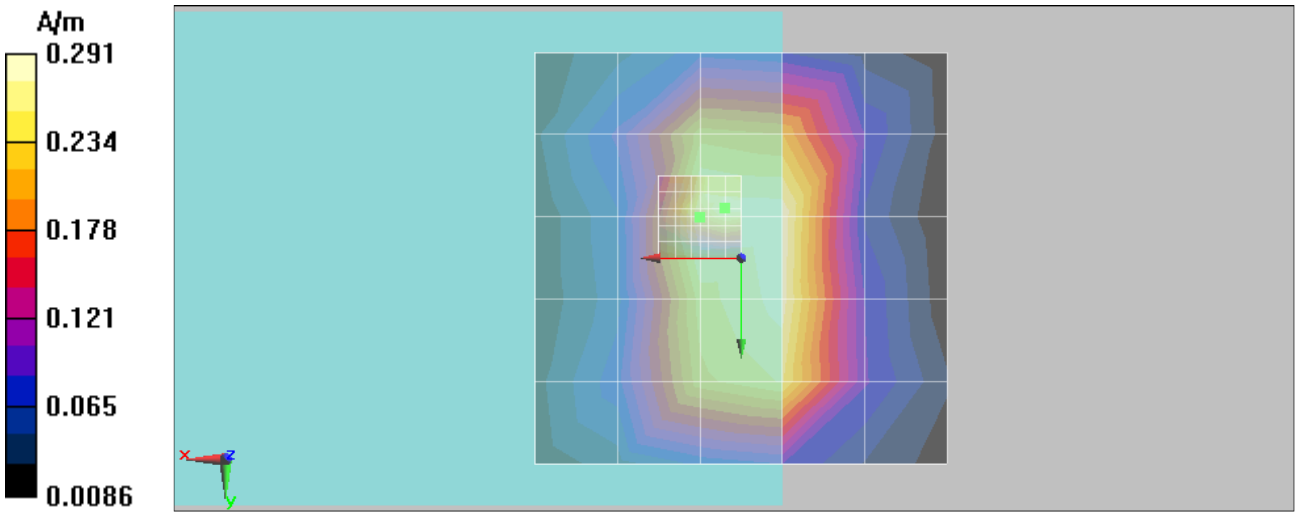
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -7.17 dB A/m
BWC Factor = 0.155979 dB
Location: 2, -6, 3 mm

Point scan/y (transversal) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 42.6 dB
ABM1 comp = -6.92 dB A/m
BWC Factor = 0.155979 dB
Location: 2, -6, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA850 CH384_AXIAL

DUT: RHOD 500

Communication System: CDMA; Frequency: 836.5 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -4.08 dB A/m
BWC Factor = 0.157003 dB
Location: -5, -5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.157003 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -0.729 dB A/m
BWC Factor = 0.157003 dB
Location: -2, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

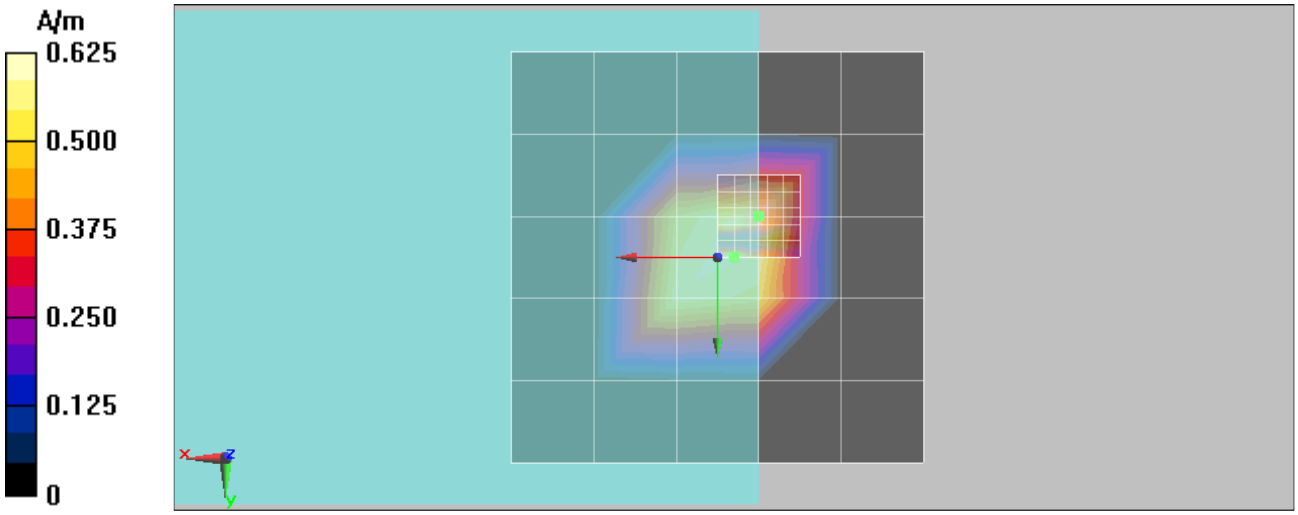
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 41.4 dB
ABM1 comp = -0.211 dB A/m
BWC Factor = 0.155979 dB
Location: -2, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 45.8 dB
ABM1 comp = 4.24 dB A/m
BWC Factor = 10.8 dB
Location: -2, 0, 3 mm



Test Laboratory: Bureau Veritas ADT

T-COIL CDMA1900 CH1175_AXIAL

DUT: RHOD500

Communication System: CDMA; Frequency: 1908.75 MHz;Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m^3
Phantom section: TCoil Section
Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

Probe: AM1DV3 - 3060; ; Calibrated: 2008/12/3
Sensor-Surface: 0mm (Fix Surface)
Electronics: DAE4 Sn861; Calibrated: 2008/9/22
Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
Measurement SW: DASY5, V5.0 Build 125; SEMCAD X Version 13.4 Build 125

Coarse Scans/z (axial) scan 50 x 50 (grid 10) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155041 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = -4.6 dB A/m
BWC Factor = 0.155041 dB
Location: 5, 5, 3 mm

Fine scan/z (axial) scan 10 x 10 (grid 2) with noise/ABM Signal(x,y,z) (6x6x1):

Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1 comp = 1.52 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) scan at point with noise/ABM SNR(x,y,z) (1x1x1):

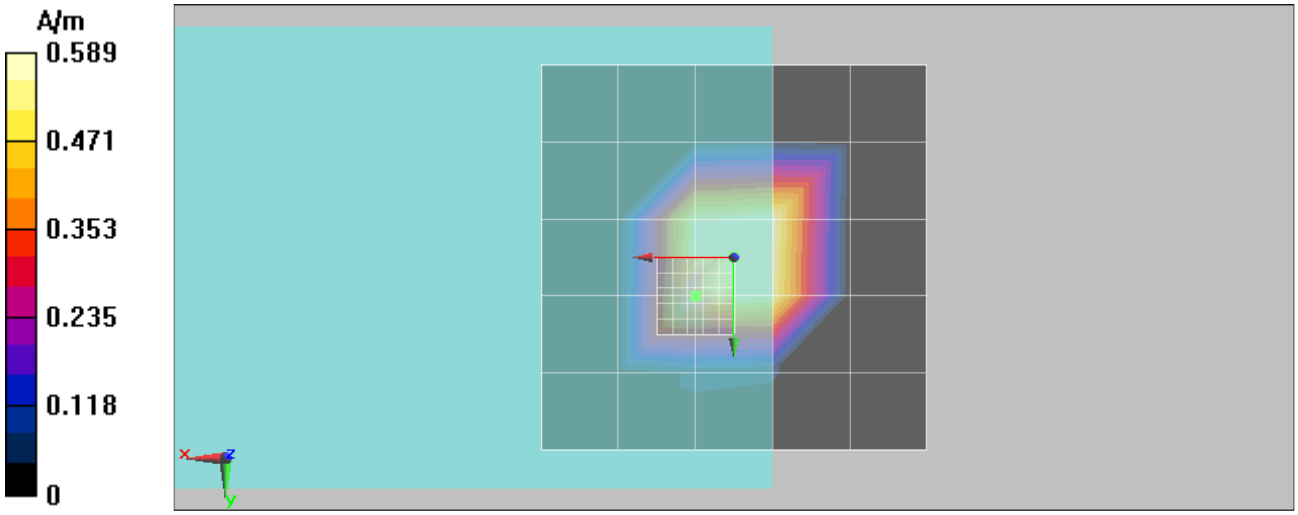
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_1kHz_1s.wav
Output Gain: 30.03
Measure Window Start: 0ms
Measure Window Length: 1000ms
BWC applied: 0.155979 dB
Device Reference Point: 0, 0, -6.3 mm

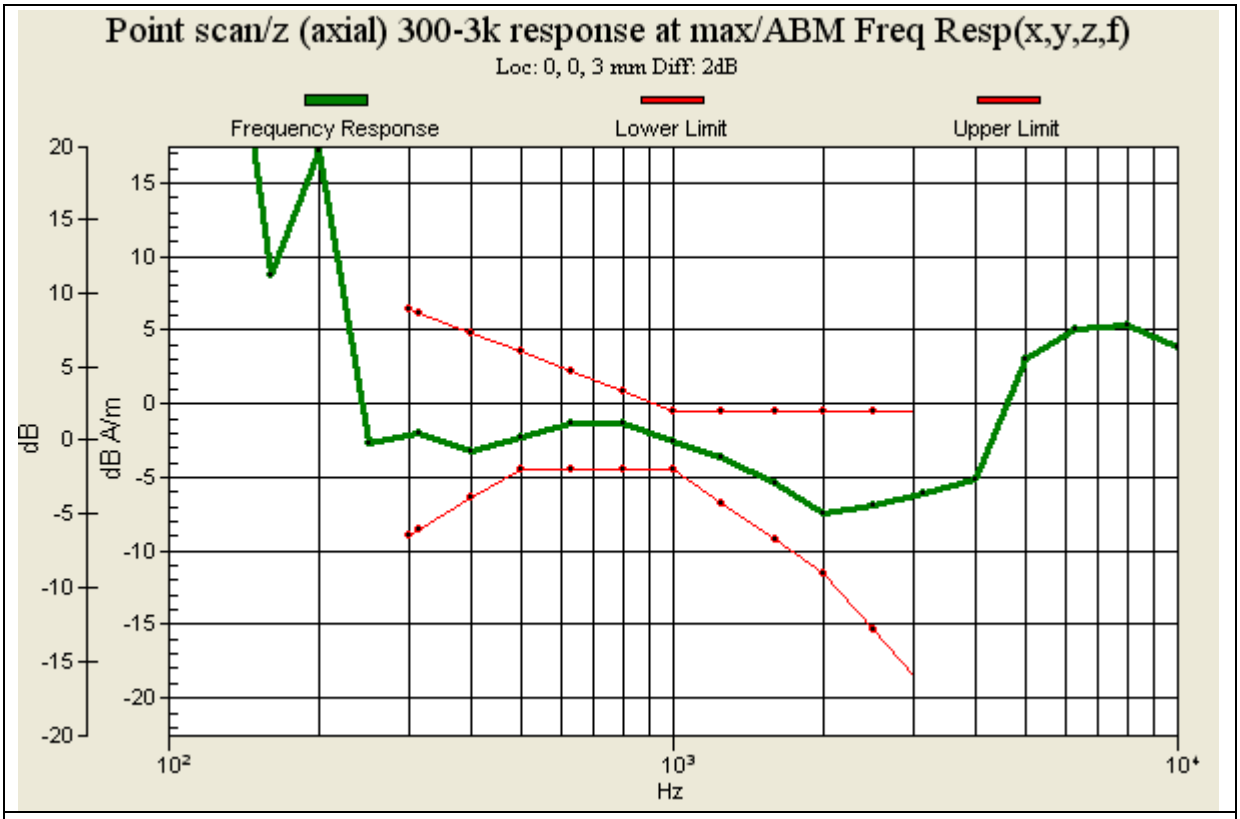
Cursor:
ABM1/ABM2 = 44.4 dB
ABM1 comp = 2.05 dB A/m
BWC Factor = 0.155979 dB
Location: 0, 0, 3 mm

Point scan/z (axial) 300-3k response at max/ABM SNR(x,y,z) (1x1x1):

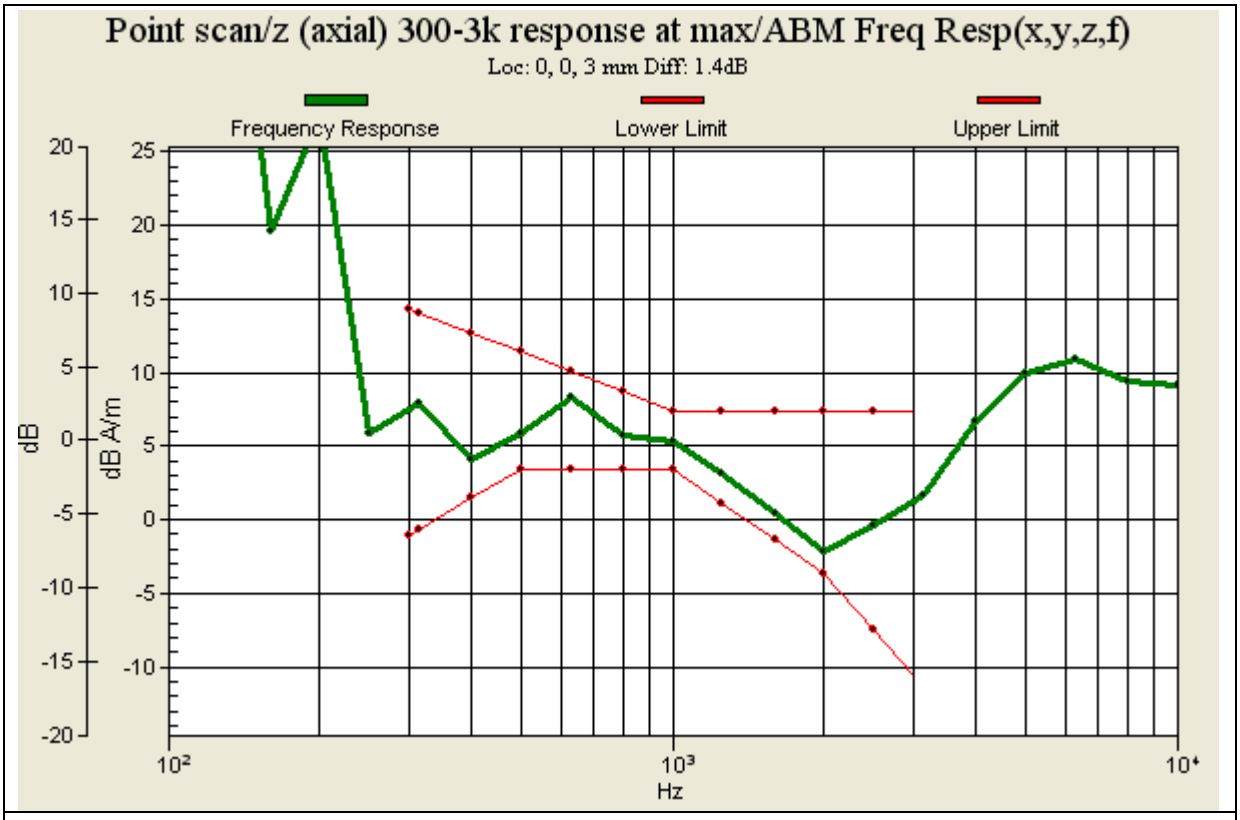
Measurement grid: dx=10mm, dy=10mm
Signal Type: Audio File (.wav) 48k_voice_300-3000_2s.wav
Output Gain: 58.8
Measure Window Start: 2000ms
Measure Window Length: 2000ms
BWC applied: 10.8 dB
Device Reference Point: 0, 0, -6.3 mm

Cursor:
ABM1/ABM2 = 48.5 dB
ABM1 comp = 6.33 dB A/m
BWC Factor = 10.8 dB
Location: 0, 0, 3 mm

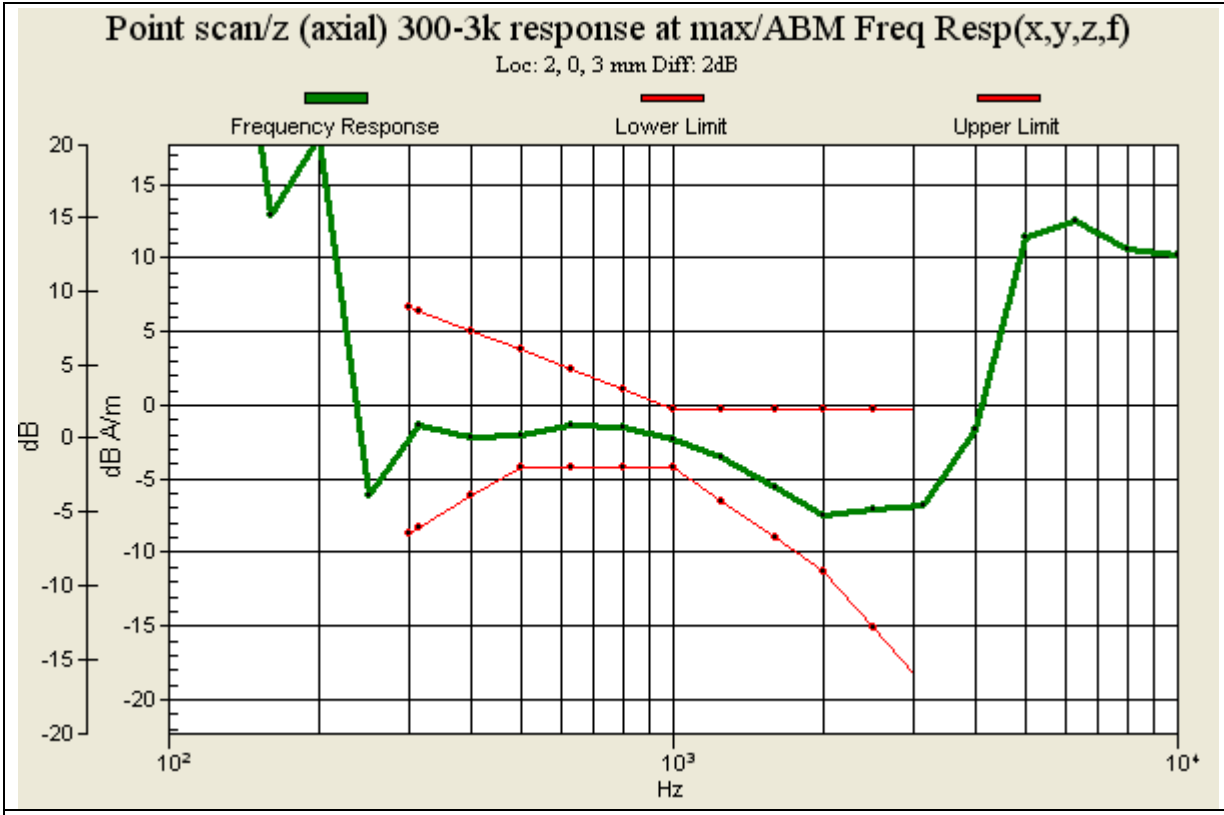




T-Coil CDMA850 Ch1013_Axial Frequency Response



T-Coil CDMA850 Ch384_Axial Frequency Response



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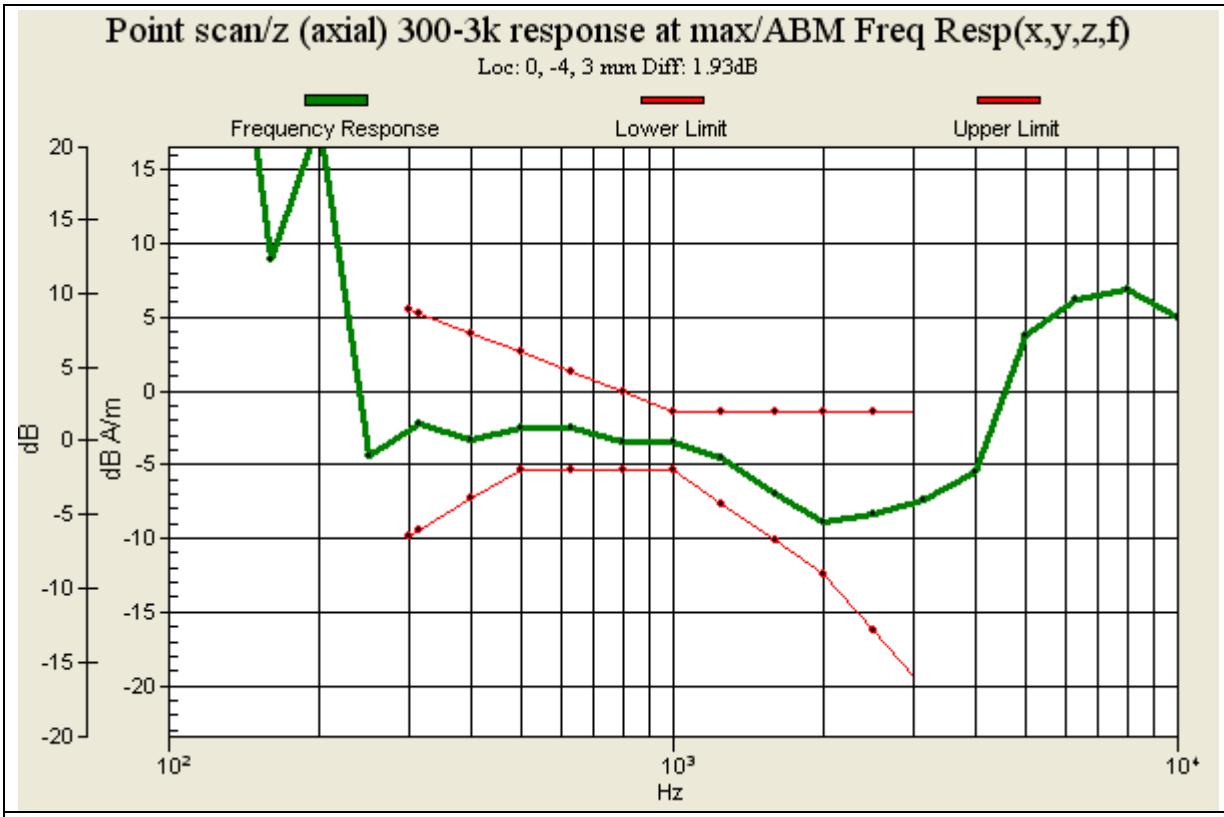

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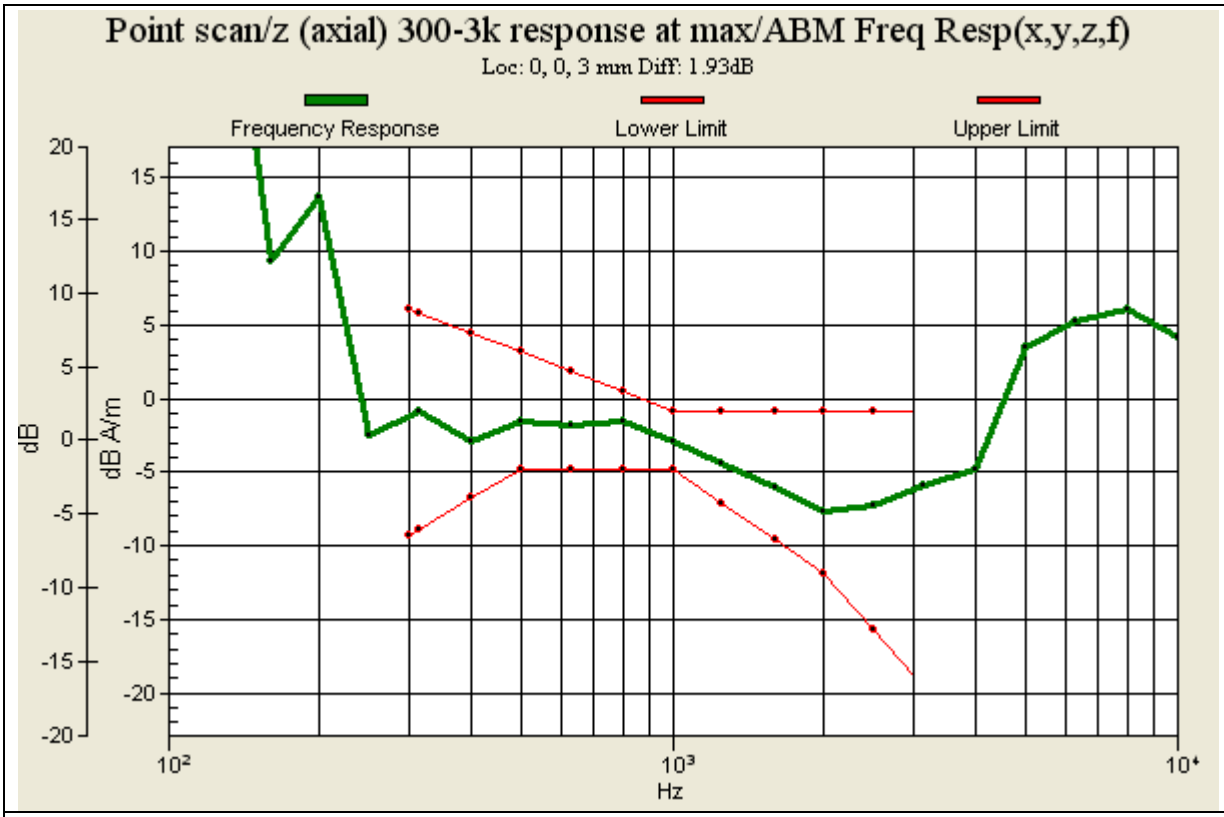

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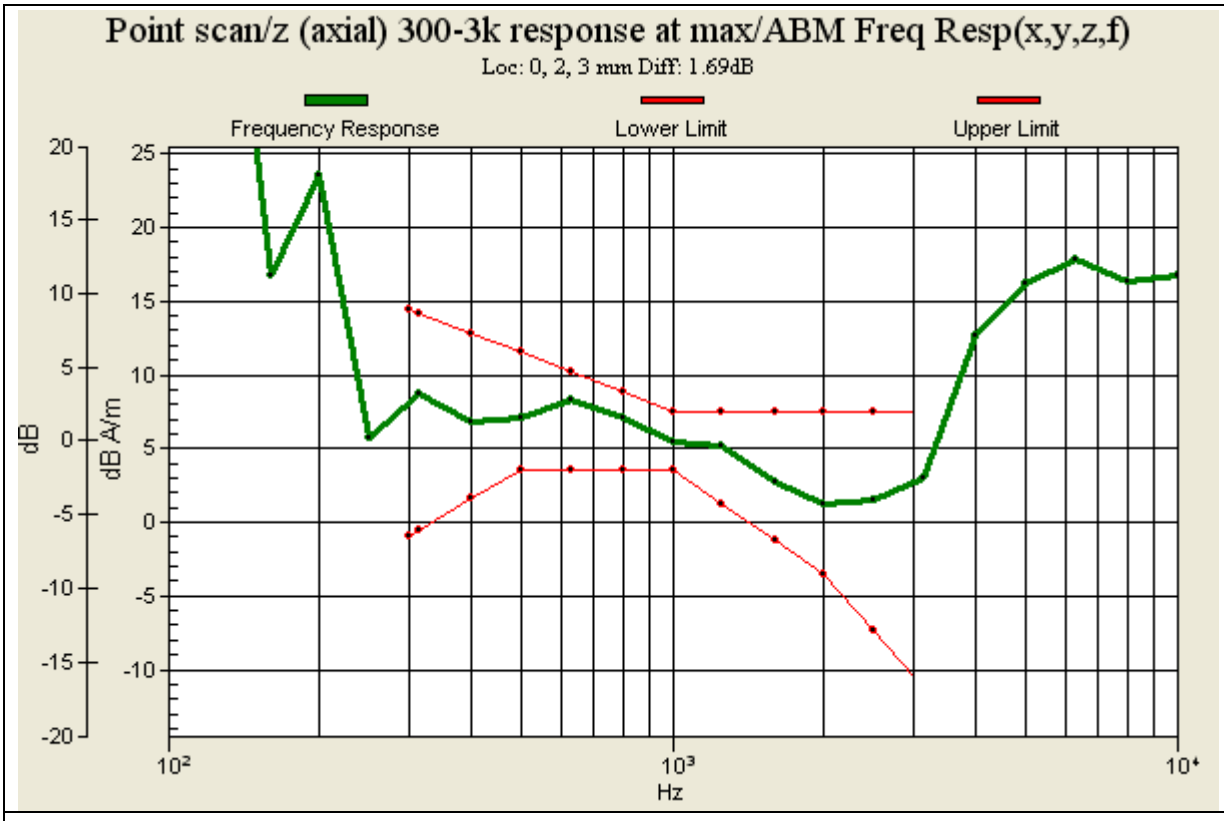
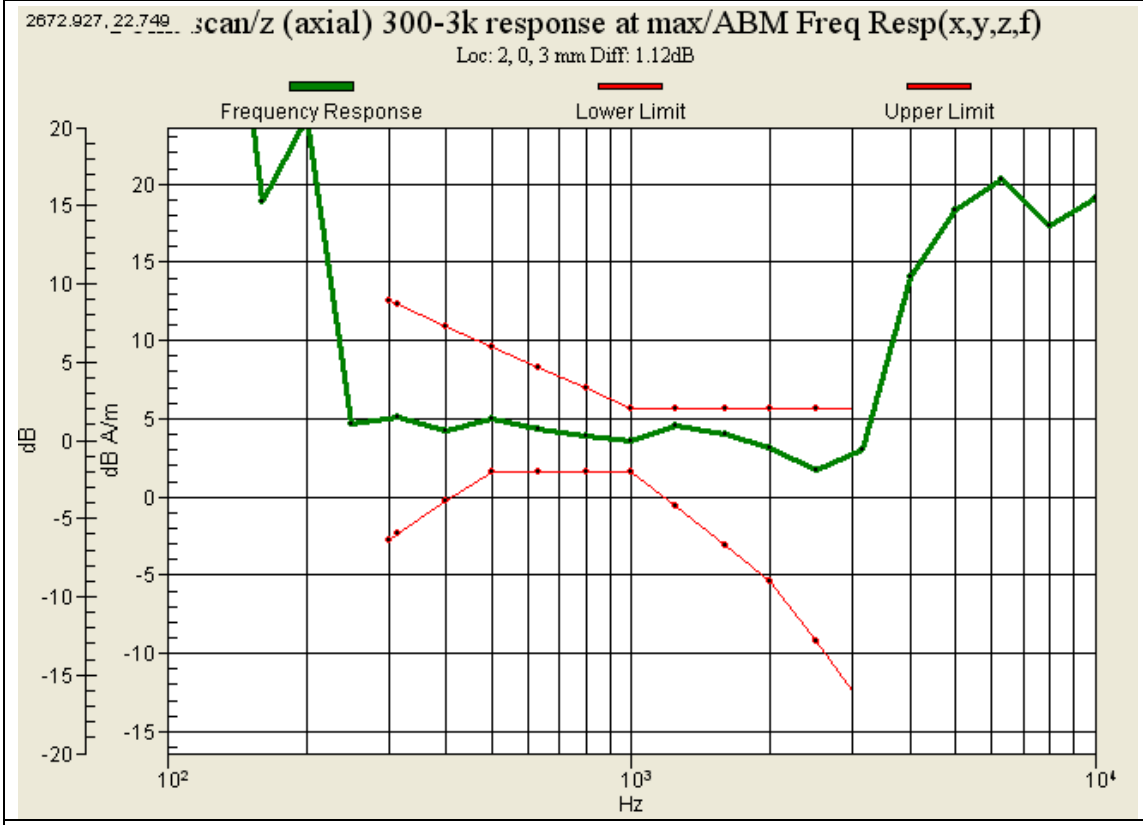
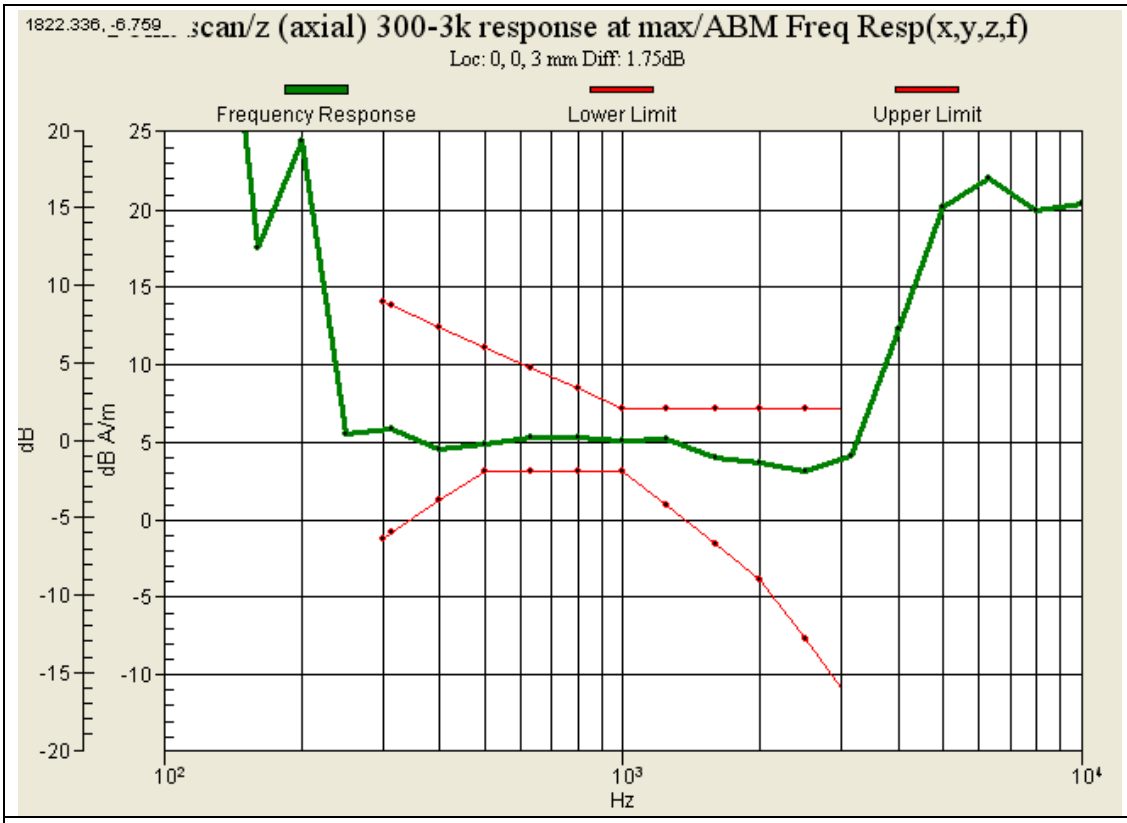


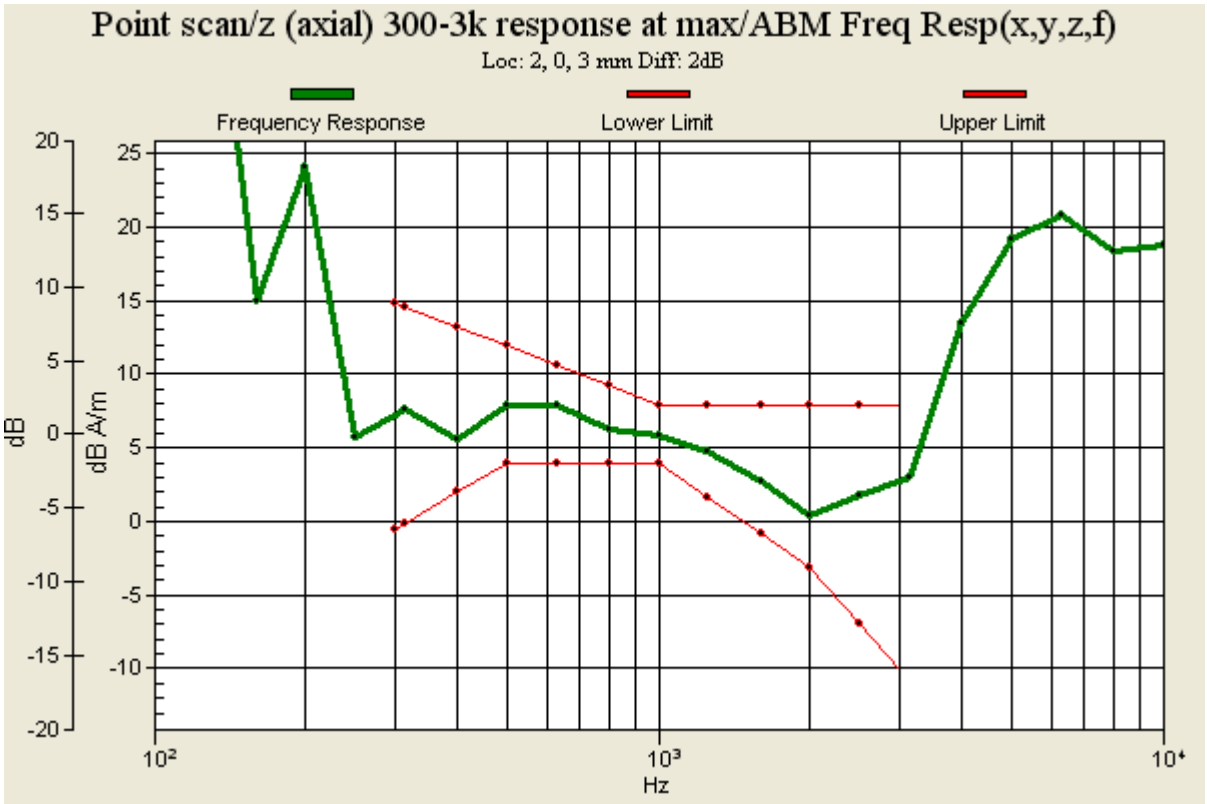
T-Coil CDMA1900 Ch1175_Axial Frequency Response



T-Coil CDMA850 Ch384_Axial Frequency Response



T-Coil CDMA1900 Ch1175_Axial Frequency Response



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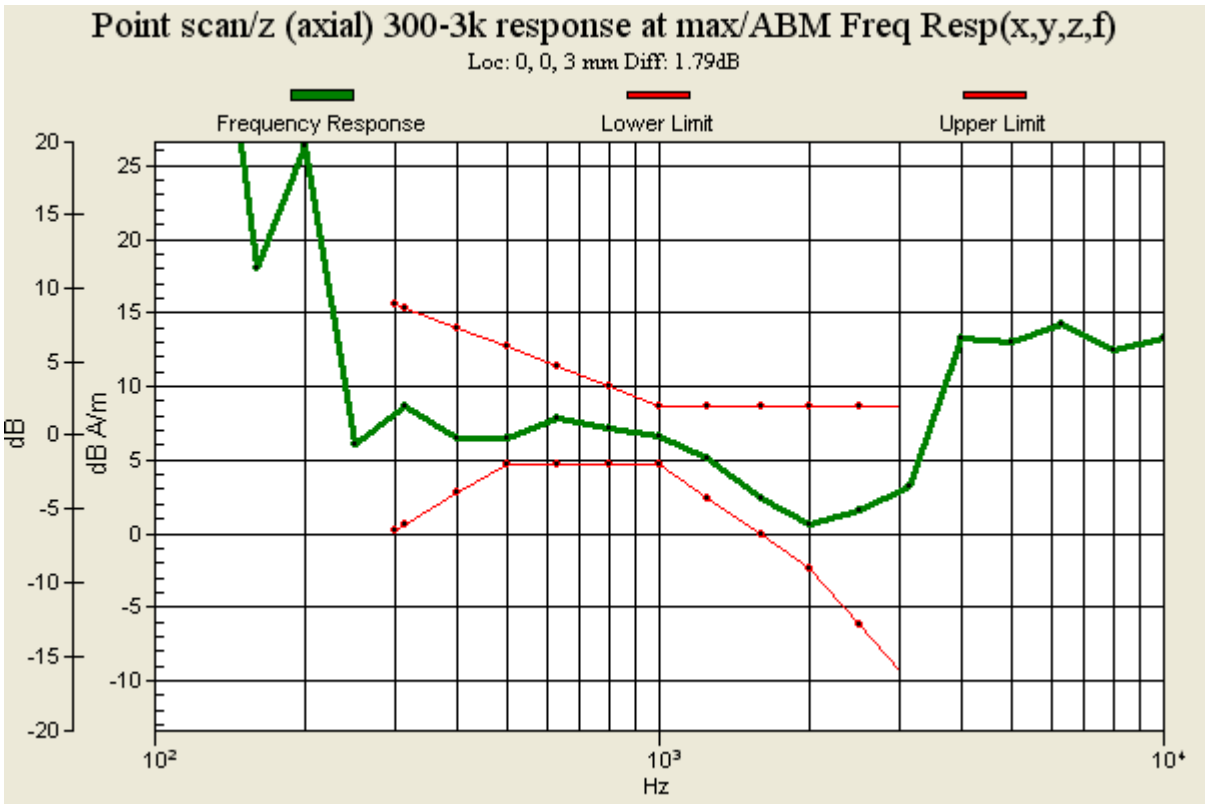

T-Coil CDMA1900 Ch1175_Axial Frequency Response

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Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 108

Client **ADT (Auden)**

Certificate No: AM1DV3-3060_Dec08

CALIBRATION CERTIFICATE

Object	AM1DV3 - SN: 3060
Calibration procedure(s)	QA CAL-24.v2 Calibration procedure for AM1D magnetic field probes and TMFS in the audio range
Calibration date:	December 3, 2008
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Reference Probe AM1DV3	SN: 3000	22-Oct-08 (No. AM1D-3000_Oct08)	Oct-09
DAE4	SN: 781	03-Oct-08 (No. DAE4-781_Oct08)	Oct-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
AMCC	1050	15-Aug-08 (in house check Aug-08)	Aug-09

	Name	Function	Signature
Calibrated by:	Mike Meili	RF Technician	
Approved by:	Fin Bomholt	R&D Director	

Issued: December 4, 2008

References

[1] ANSI C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

[2] DASY4 manual, Chapter: Hearing Aid Compatibility (HAC) T-Coil Extension

Description of the AM1D probe

The AM1D Audio Magnetic Field Probe is a fully shielded magnetic field probe for the frequency range from 100 Hz to 20 kHz. The pickup coil is compliant with the dimensional requirements of [1]. The probe includes a symmetric low noise amplifier for the signal available at the shielded 3 pin connector at the side. Power is supplied via the same connector (phantom power supply) and monitored via the LED near the connector. The 7 pin connector at the end of the probe does not carry any signals, but determines the angle of the sensor when mounted on the DAE. The probe supports mechanical detection of the surface.
The single sensor in the probe is arranged in a tilt angle allowing measurement of 3 orthogonal field components when rotating the probe by 120° around its axis. It is aligned with the perpendicular component of the field, if the probe axis is tilted nominally 35.3° above the measurement plane, using the connector rotation and sensor angle stated below.
The probe is fully RF shielded when operated with the matching signal cable (shielded) and allows measurement of audio magnetic fields in the close vicinity of RF emitting wireless devices according to [1] without additional shielding.

Handling of the item

The probe is manufactured from stainless steel. In order to maintain the performance and calibration of the probe, it must not be opened. The probe is designed for operation in air and shall not be exposed to humidity or liquids. For proper operation of the surface detection and emergency stop functions in a DASY system, the probe must be operated with the special probe cup provided (larger diameter).

Methods Applied and Interpretation of Parameters

- *Coordinate System:* The AM1D probe is mounted in the DASY system for operation with a HAC Test Arch phantom with AMCC Helmholtz calibration coil according to [2], with the tip pointing to "southwest" orientation.
- *Functional Test:* The functional test preceding calibration includes test of
  Noise level
  RF immunity (1kHz AM modulated signal). The shield of the probe cable must be well connected.
  Frequency response verification from 100 Hz to 5 kHz.
- *Connector Rotation:* The connector at the end of the probe does not carry any signals and is used for fixation to the DAE only. The probe is operated in the center of the AMCC Helmholtz coil using a 1 kHz magnetic field signal. Its angle is determined from the two minima at nominally +120° and –120° rotation, so the sensor in the tip of the probe is aligned to the vertical plane in z-direction, corresponding to the field maximum in the AMCC Helmholtz calibration coil.
- *Sensor Angle:* The sensor tilting in the vertical plane from the ideal vertical direction is determined from the two minima at nominally +120° and –120°. DASY system uses this angle to align the sensor for radial measurements to the x and y axis in the horizontal plane.
- *Sensitivity:* With the probe sensor aligned to the z-field in the AMCC, the output of the probe is compared to the magnetic field in the AMCC at 1 kHz. The field in the AMCC Helmholtz coil is given by the geometry and the current through the coil, which is monitored on the precision shunt resistor of the coil.

AM1D probe identification and configuration data

Item	**AM1DV3** Audio Magnetic 1D Field Probe
Type No	SP AM1 001 BA
Serial No	**3060**

Overall length	296 mm
Tip diameter	6.0 mm (at the tip)
Sensor offset	3.0 mm (centre of sensor from tip)
Internal Amplifier	20 dB

Manufacturer / Origin	Schmid & Partner Engineering AG, Zürich, Switzerland
Manufacturing date	Oct-2008
Last calibration date	December 3, 2008

Calibration data

Connector rotation angle	(in DASY system)	**53.4** °	+/- 3.6 ° (k=2)
Sensor angle	(in DASY system)	**0.06** °	+/- 0.5 ° (k=2)
Sensitivity at 1 kHz	(in DASY system)	**0.00732 V / (A/m)**	+/- 2.2 % (k=2)

Schmid & Partner Engineering AG

s p e a g

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Phone +41 44 245 9700, Fax +41 44 245 9779
info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out .

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration Customer shall remove the batteries and pack the DAE in an antistatic bag. The packaging shall protect the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, Customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

Important Note:
Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:
Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

_____
Schmid & Partner Engineering

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 108

Client **Jabil Circuits (Auden)**

Certificate No: DAE4-861_Sep08

CALIBRATION CERTIFICATE

Object	DAE4 - SD 000 D04 BG - SN: 861
Calibration procedure(s)	QA CAL-06.v12 Calibration procedure for the data acquisition electronics (DAE)
Calibration date:	September 22, 2008
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	04-Oct-07 (No: 6467)	Oct-08
Keithley Multimeter Type 2001	SN: 0810278	03-Oct-07 (No: 6465)	Oct-08
Secondary Standards	**ID #**	**Check Date (in house)**	**Scheduled Check**
Calibrator Box V1.1	SE UMS 006 AB 1004	06-Jun-08 (in house check)	In house check: Jun-09

	Name	Function	Signature
Calibrated by:	Andrea Guntli	Technician	
Approved by:	Fin Bomholt	R&D Director	i.V.

Issued: September 25, 2008

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
  - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
  - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
  - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
  - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
  - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
  - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
  - *Input resistance:* DAE input resistance at the connector, during internal auto-zeroing and during measurement.
  - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
  - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range:	1LSB =	6.1μV ,	full range =	-100...+300 mV
Low Range:	1LSB =	61nV ,	full range =	-1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.365 ± 0.1% (k=2)	404.742 ± 0.1% (k=2)	405.670 ± 0.1% (k=2)
Low Range	4.02029 ± 0.7% (k=2)	3.98762 ± 0.7% (k=2)	4.01204 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	124 ° ± 1 °

Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	199999.9	0.00
Channel X	+ Input	20000	20002.71	0.01
Channel X	- Input	20000	-20003.54	0.02
Channel Y	+ Input	200000	200000.3	0.00
Channel Y	+ Input	20000	19999.17	0.00
Channel Y	- Input	20000	-20003.37	0.02
Channel Z	+ Input	200000	199999.8	0.00
Channel Z	+ Input	20000	20000.36	0.00
Channel Z	- Input	20000	-20005.96	0.03

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000	0.00
Channel X	+ Input	200	199.92	-0.04
Channel X	- Input	200	-200.25	0.13
Channel Y	+ Input	2000	1999.9	0.00
Channel Y	+ Input	200	199.32	-0.34
Channel Y	- Input	200	-200.67	0.33
Channel Z	+ Input	2000	2000	0.00
Channel Z	+ Input	200	199.65	-0.18
Channel Z	- Input	200	-201.81	0.91

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.10	4.08
	- 200	-4.32	-4.27
Channel Y	200	1.83	1.39
	- 200	-2.21	-3.06
Channel Z	200	-10.14	-10.20
	- 200	8.87	7.81

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.33	0.83
Channel Y	200	0.10	-	4.12
Channel Z	200	-0.22	0.96	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15980	15973
Channel Y	16090	15869
Channel Z	16031	16364

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.05	-2.16	1.46	0.57
Channel Y	-0.73	-2.87	1.71	0.55
Channel Z	-1.37	-4.32	0.61	0.75

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	197.8
Channel Y	0.2000	200.0
Channel Z	0.1999	198.0

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	–0.01	-8	-9